

# AMC1035 Delta-Sigma Modulator

## With Bipolar Input of $\pm 1$ V and Reference Output of 2.5 V

### 1 Features

- Delta-sigma modulator optimized for voltage and temperature sensing:
  - $\pm 1$ -V input voltage range
  - High differential input resistance: 1.6 G $\Omega$  (typ)
  - Integrated 2.5-V,  $\pm 5$ -mA reference for ratiometric measurement
- Excellent DC performance:
  - Offset error:  $\pm 0.5$  mV (max)
  - Offset drift:  $\pm 6$   $\mu$ V/ $^{\circ}$ C (max)
  - Gain error:  $\pm 0.25\%$  (max)
  - Gain drift:  $\pm 45$  ppm/ $^{\circ}$ C (max)
  - Ratiometric gain drift:  $\pm 15$  ppm/ $^{\circ}$ C (max)
- Selectable manchester encoded or uncoded bitstream output
- Fully specified over the extended industrial temperature range:  $-40^{\circ}$ C to  $+125^{\circ}$ C

### 2 Applications

- AC voltage and temperature sensing in industrial applications:
  - [Motor drives](#)
  - [Photovoltaic inverters](#)
  - [Uninterruptible power supplies](#)
  - [Industrial transport systems](#)

### 3 Description

The AMC1035 is a precision delta-sigma ( $\Delta\Sigma$ ) modulator that operates from a single 3.0-V to 5.5-V supply and with an externally supplied clock signal in the range of 9 MHz to 21 MHz. In Manchester mode, the specified clock range is 9 MHz to 11 MHz. The differential  $\pm 1$ -V input structure of the device is optimized for high noise environments typical for industrial applications.

Select the output bitstream of the AMC1035 to be Manchester coded to prevent setup and hold time requirement considerations of the receiving device and reduce overall circuit layout efforts. When used with a digital filter (such as integrated in the [TMS320F28004x](#), [TMS320F2807x](#) or [TMS320F2837x](#) microcontroller families) to decimate the output bitstream, the device can achieve 16 bits of resolution with a dynamic range of 87 dB at a data rate of 82 kSPS.

The internal reference source of the AMC1035 supports ratiometric circuit architecture to minimize the negative impact of the supply voltage variation and temperature drift on the accuracy of the measurement.

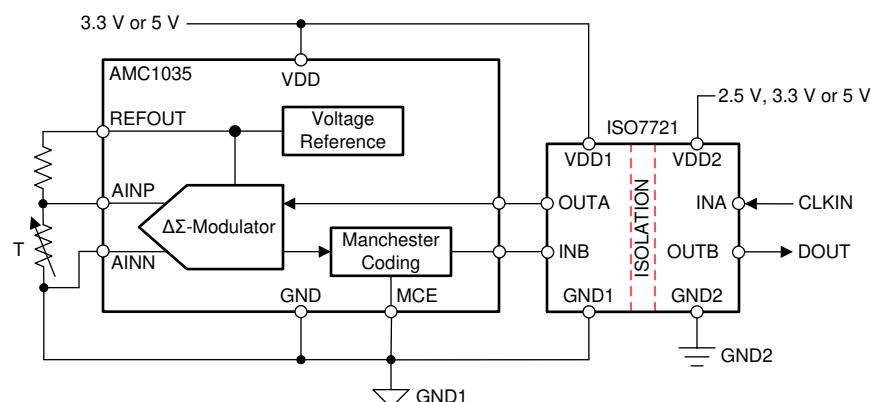
The AMC1035 can also be used for AC power line voltage sensing with a digital isolator and isolated power supply.

#### Device Information<sup>(1)</sup>

| PART NUMBER | PACKAGE  | BODY SIZE (NOM)        |
|-------------|----------|------------------------|
| AMC1035     | SOIC (8) | 4.9 mm $\times$ 3.9 mm |

(1) For all available packages, see the orderable addendum at the end of the datasheet.

#### Application Example



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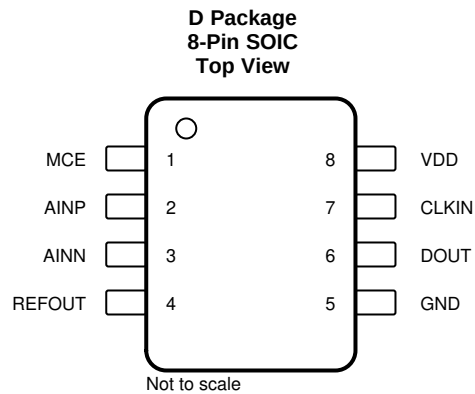
## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision A (November 2018) to Revision B                                                                                           | Page      |
|-------------------------------------------------------------------------------------------------------------------------------------------------|-----------|
| • Deleted PSRR specification for $T_A > 85^\circ\text{C}$ from <i>Reference Output</i> section of <i>Electrical Characteristics</i> table ..... | <b>6</b>  |
| • Changed SINAD equation .....                                                                                                                  | <b>22</b> |

| Changes from Original (August 2018) to Revision A                           | Page     |
|-----------------------------------------------------------------------------|----------|
| • Changed document status from Advance Information to Production Data ..... | <b>1</b> |

## 5 Pin Configuration and Functions



### Pin Functions

| PIN |        | I/O | DESCRIPTION                                                                                                                                                                                                                                                                   |
|-----|--------|-----|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NO. | NAME   |     |                                                                                                                                                                                                                                                                               |
| 1   | MCE    | I   | Manchester coding enabled, active high, with internal pulldown resistor (typical value: 200 kΩ). The polarity of this signal must not be changed when the clock signal is applied.                                                                                            |
| 2   | AINP   | I   | Noninverting analog input.                                                                                                                                                                                                                                                    |
| 3   | AINN   | I   | Inverting analog input.                                                                                                                                                                                                                                                       |
| 4   | REFOUT | O   | Reference output: 2.5 V nominal, maximum ±5-mA sink and source capability.                                                                                                                                                                                                    |
| 5   | GND    | —   | Ground reference.                                                                                                                                                                                                                                                             |
| 6   | DOUT   | O   | Modulator bitstream data output, updated with the rising edge of the clock signal present on CLKIN. This pin is a Manchester coded output if MCE is pulled high. Use the rising edge of the clock to latch the modulator bitstream at the input of the digital filter device. |
| 7   | CLKIN  | I   | Modulator clock input: 9 MHz to 21 MHz with an internal pulldown resistor (typical value: 200 kΩ). The clock signal must be applied continuously for proper device operation; see the <a href="#">Clock Input</a> section for additional details.                             |
| 8   | VDD    | —   | Power supply, 3.0 V to 5.5 V. See the <a href="#">Power Supply Recommendations</a> section for decoupling recommendations.                                                                                                                                                    |

## 6 Specifications

### 6.1 Absolute Maximum Ratings

see <sup>(1)</sup>

|                                             | MIN       | MAX       | UNIT |
|---------------------------------------------|-----------|-----------|------|
| Supply voltage, VDD to GND                  | −0.3      | 7         | V    |
| Analog input voltage at AINP, AINN          | GND − 5   | VDD + 0.5 | V    |
| Analog output voltage at REFOUT             | GND − 0.5 | VDD + 0.5 | V    |
| Digital input voltage at CLKIN or MCE       | GND − 0.5 | VDD + 0.5 | V    |
| Digital output voltage at DOUT              | GND − 0.5 | VDD + 0.5 | V    |
| Input current to any pin except supply pins | −10       | 10        | mA   |
| Junction temperature, T <sub>J</sub>        |           | 150       | °C   |
| Storage temperature, T <sub>stg</sub>       | −65       | 150       | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 6.2 ESD Ratings

|                    |                         |                                                                                | VALUE | UNIT |
|--------------------|-------------------------|--------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±2000 | V    |
|                    |                         | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±1000 |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.  
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

|                       |                                                    |                                                                                                                                   | MIN   | NOM | MAX       | UNIT |
|-----------------------|----------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------|-------|-----|-----------|------|
| POWER SUPPLY          |                                                    |                                                                                                                                   |       |     |           |      |
| VDD                   | Supply voltage                                     | VDD to GND                                                                                                                        | 3.0   | 3.3 | 5.5       | V    |
| ANALOG INPUT          |                                                    |                                                                                                                                   |       |     |           |      |
| V <sub>Clipping</sub> | Differential input voltage before clipping output  | V <sub>IN</sub> = V <sub>AINP</sub> − V <sub>AINN</sub>                                                                           | ±1.25 |     |           | V    |
| V <sub>FSR</sub>      | Specified linear differential full-scale voltage   | V <sub>IN</sub> = V <sub>AINP</sub> − V <sub>AINN</sub>                                                                           | −1    |     | 1         | V    |
|                       | Absolute common-mode input voltage <sup>(1)</sup>  | (V <sub>AINP</sub> + V <sub>AINN</sub> ) / 2 to GND                                                                               | −2    |     | VDD       | V    |
| V <sub>CM</sub>       | Operating common-mode input voltage <sup>(2)</sup> | (V <sub>AINP</sub> + V <sub>AINN</sub> ) / 2 to GND,<br>3.0 V ≤ VDD < 4 V,<br>V <sub>AINP</sub> = V <sub>AINN</sub>               | −1.4  |     | VDD − 1.4 | V    |
|                       |                                                    | (V <sub>AINP</sub> + V <sub>AINN</sub> ) / 2 to GND,<br>3.0 V ≤ VDD < 4.5 V,<br> V <sub>AINP</sub> − V <sub>AINN</sub>   = 1.25 V | −0.8  |     | VDD − 2.4 |      |
|                       |                                                    | (V <sub>AINP</sub> + V <sub>AINN</sub> ) / 2 to GND,<br>4 V ≤ VDD ≤ 5.5 V,<br>V <sub>AINP</sub> = V <sub>AINN</sub>               | −1.4  |     | 2.7       |      |
|                       |                                                    | (V <sub>AINP</sub> + V <sub>AINN</sub> ) / 2 to GND,<br>4.5 V ≤ VDD ≤ 5.5 V,<br> V <sub>AINP</sub> − V <sub>AINN</sub>   = 1.25 V | −0.8  |     | 2.1       |      |
| DIGITAL INPUT         |                                                    |                                                                                                                                   |       |     |           |      |
|                       | Input voltage                                      | V <sub>MCE</sub> or V <sub>CLKIN</sub> to GND                                                                                     | GND   |     | VDD       | V    |
| TEMPERATURE RANGE     |                                                    |                                                                                                                                   |       |     |           |      |
| T <sub>A</sub>        | Operating ambient temperature                      |                                                                                                                                   | −40   | 25  | 125       | °C   |

- (1) Steady-state voltage supported by the device in case of a system failure. See specified common-mode input voltage V<sub>CM</sub> for normal operation. Observe analog input voltage range as specified in the [Absolute Maximum Ratings](#) table.  
(2) See the [Analog Input](#) section for more details.

## 6.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | AMC1035  | UNIT |
|-------------------------------|----------------------------------------------|----------|------|
|                               |                                              | D (SOIC) |      |
|                               |                                              | 8 PINS   |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 120      | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 52       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 61       | °C/W |
| ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 10       | °C/W |
| ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 60       | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | n/a      | °C/W |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics

minimum and maximum specifications apply from T<sub>A</sub> = –40°C to +125°C, VDD = 3.0 V to 5.5 V, AINP = –1 V to 1 V, AINN = GND, and sinc<sup>3</sup> filter with OSR = 256 (unless otherwise noted); typical specifications are at T<sub>A</sub> = 25°C, CLKIN = 20 MHz, and VDD = 3.3 V

| PARAMETER                        |                                                                  | TEST CONDITIONS                                                                                  | MIN        | TYP    | MAX   | UNIT   |
|----------------------------------|------------------------------------------------------------------|--------------------------------------------------------------------------------------------------|------------|--------|-------|--------|
| ANALOG INPUTS                    |                                                                  |                                                                                                  |            |        |       |        |
| V <sub>CMUV</sub> <sup>(1)</sup> | Negative common-mode undervoltage detection level <sup>(2)</sup> | (V <sub>AINP</sub> + V <sub>AINN</sub> ) / 2, V <sub>AINP</sub> = V <sub>AINN</sub>              | –1.45      |        |       | V      |
|                                  |                                                                  | (V <sub>AINP</sub> + V <sub>AINN</sub> ) / 2,  V <sub>AINP</sub> – V <sub>AINN</sub>   = 1.25 V  | –0.85      |        |       |        |
| V <sub>CMOV</sub> <sup>(1)</sup> | Positive common-mode overvoltage detection level <sup>(2)</sup>  | 3.0 V ≤ VDD < 4 V, V <sub>AINP</sub> = V <sub>AINN</sub>                                         | VDD – 1.35 |        |       | V      |
|                                  |                                                                  | 3.0 V ≤ VDD < 4.5 V,  V <sub>AINP</sub> – V <sub>AINN</sub>   = 1.25 V                           | VDD – 2.35 |        |       |        |
|                                  |                                                                  | 4 V ≤ VDD ≤ 5.5 V, V <sub>AINP</sub> = V <sub>AINN</sub>                                         | 2.75       |        |       |        |
|                                  |                                                                  | 4.5 V ≤ VDD ≤ 5.5 V,  V <sub>AINP</sub> – V <sub>AINN</sub>   = 1.25 V                           | 2.15       |        |       |        |
| R <sub>IN</sub>                  | Single-ended input resistance                                    | AINN = GND                                                                                       | 0.1        | 0.4    |       | GΩ     |
| R <sub>IND</sub>                 | Differential input resistance                                    |                                                                                                  | 0.16       | 1.6    |       | GΩ     |
| C <sub>IN</sub>                  | Single-ended input capacitance                                   | AINN = GND                                                                                       |            | 2      |       | pF     |
| C <sub>IND</sub>                 | Differential input capacitance                                   |                                                                                                  |            | 2      |       | pF     |
| I <sub>IB</sub>                  | Input bias current                                               | AINP = AINN = GND, (I <sub>AINP</sub> + I <sub>AINN</sub> ) / 2                                  | –10        | ±3     | 10    | nA     |
| TC <sub>IIB</sub>                | Input bias current thermal drift                                 | AINP = AINN = GND, (I <sub>AINP</sub> + I <sub>AINN</sub> ) / 2                                  |            | ±5     |       | pA/°C  |
| I <sub>IO</sub>                  | Input offset current                                             | I <sub>IO</sub> = I <sub>AINP</sub> – I <sub>AINN</sub>                                          | –5         | ±1     | 5     | nA     |
| CMRR                             | Common-mode rejection ratio                                      | AINP = AINN, f <sub>IN</sub> = 0 Hz, V <sub>CM min</sub> ≤ V <sub>IN</sub> ≤ V <sub>CM max</sub> | –104       |        |       | dB     |
|                                  |                                                                  | AINP = AINN, f <sub>IN</sub> from 0.1 Hz to 50 kHz, –0.5 V ≤ V <sub>IN</sub> ≤ 0.5 V             | –88        |        |       |        |
| DC ACCURACY                      |                                                                  |                                                                                                  |            |        |       |        |
|                                  | Resolution <sup>(3)</sup>                                        |                                                                                                  | 16         |        |       | Bits   |
| INL                              | Integral nonlinearity <sup>(4)</sup>                             | Resolution: 16 bits                                                                              | –12        | ±2     | 12    | LSB    |
| E <sub>O</sub>                   | Offset error                                                     | Initial, at T <sub>A</sub> = 25°C, AINP = AINN = GND                                             | –0.5       | ±0.03  | 0.5   | mV     |
| TCE <sub>O</sub>                 | Offset error thermal drift <sup>(5)</sup>                        |                                                                                                  | –6         | ±0.1   | 6     | μV/°C  |
| E <sub>G</sub>                   | Gain error                                                       | Initial, at T <sub>A</sub> = 25°C                                                                | –0.25%     | ±0.02% | 0.25% |        |
|                                  |                                                                  | Initial, at T <sub>A</sub> = 25°C, ratiometric mode                                              | –0.3%      | ±0.02% | 0.3%  |        |
| TCE <sub>G</sub>                 | Gain error thermal drift <sup>(6)</sup>                          |                                                                                                  | –45        | ±20    | 45    | ppm/°C |
|                                  |                                                                  | Ratiometric mode                                                                                 | –15        | ±4     | 15    |        |
| PSRR                             | Power-supply rejection ratio                                     | AINP = AINN = GND, at dc                                                                         | –90        |        |       | dB     |
|                                  |                                                                  | AINP = AINN = GND, 10 kHz, 100-mV ripple                                                         | –84        |        |       |        |

(1) See the [Analog Input](#) section for more details.

(2) The common-mode overvoltage detection level has a typical hysteresis of 35 mV.

(3) The filter output is truncated to 16 bits. 16 bits of no missing codes is specified by design.

(4) Integral nonlinearity is defined as the maximum deviation from a straight line passing through the end-points of the ideal ADC transfer function expressed as number of LSBs or as a percent of the specified linear full-scale range FSR.

(5) Offset error drift is calculated using the box method, as described by the following equation:

$$TCE_O = \frac{value_{MAX} - value_{MIN}}{TempRange}$$

(6) Gain error drift is calculated using the box method, as described by the following equation:

$$TCE_G(ppm) = \left( \frac{value_{MAX} - value_{MIN}}{value \times TempRange} \right) \times 10^6$$

## Electrical Characteristics (continued)

minimum and maximum specifications apply from  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $V_{DD} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $A_{INP} = -1\text{ V}$  to  $1\text{ V}$ ,  $A_{INN} = \text{GND}$ , and sinc<sup>3</sup> filter with  $\text{OSR} = 256$  (unless otherwise noted); typical specifications are at  $T_A = 25^{\circ}\text{C}$ ,  $\text{CLKIN} = 20\text{ MHz}$ , and  $V_{DD} = 3.3\text{ V}$

| PARAMETER                                        |                                | TEST CONDITIONS                                                                                    | MIN       | TYP  | MAX       | UNIT   |
|--------------------------------------------------|--------------------------------|----------------------------------------------------------------------------------------------------|-----------|------|-----------|--------|
| AC ACCURACY                                      |                                |                                                                                                    |           |      |           |        |
| SNR                                              | Signal-to-noise ratio          | f <sub>IN</sub> = 1 kHz                                                                            | 81        | 87   |           | dB     |
| SINAD                                            | Signal-to-noise + distortion   | f <sub>IN</sub> = 1 kHz                                                                            | 77        | 83   |           | dB     |
| THD                                              | Total harmonic distortion      | f <sub>IN</sub> = 1 kHz                                                                            |           | −87  | −78       | dB     |
| SFDR                                             | Spurious-free dynamic range    | f <sub>IN</sub> = 1 kHz                                                                            | 78        | 87   |           | dB     |
| REFERENCE OUTPUT                                 |                                |                                                                                                    |           |      |           |        |
| V <sub>REFOUT</sub>                              | Reference output voltage       | Initial, at T <sub>A</sub> = 25°C, no load                                                         | 2.495     | 2.5  | 2.505     | V      |
| TCV <sub>REFOUT</sub>                            | Reference output voltage drift |                                                                                                    | −50       | ±20  | 50        | ppm/°C |
| I <sub>REFOUT</sub>                              | Reference output current       | C <sub>LOAD</sub> < 1 nF <sup>(7)</sup>                                                            | −5        |      | 5         | mA     |
|                                                  | Load regulation                | Load to GND or VDD                                                                                 |           | 0.15 | 0.35      | mV/mA  |
| I <sub>SC</sub>                                  | Short-circuit current          | REFOUT to GND                                                                                      |           | 23   |           | mA     |
|                                                  |                                | REFOUT to VDD                                                                                      |           | −21  |           |        |
| PSRR                                             | Power-supply rejection ratio   |                                                                                                    | −200      | ±30  | 200       | μV/V   |
| DIGITAL INPUTS (CMOS Logic With Schmitt-Trigger) |                                |                                                                                                    |           |      |           |        |
| I <sub>IN</sub>                                  | Input current                  | GND ≤ V <sub>IN</sub> ≤ VDD                                                                        |           |      | 35        | μA     |
| C <sub>IN</sub>                                  | Input capacitance              |                                                                                                    |           | 3    |           | pF     |
| V <sub>IH</sub>                                  | High-level input voltage       |                                                                                                    | 0.7 × VDD |      | VDD + 0.3 | V      |
| V <sub>IL</sub>                                  | Low-level input voltage        |                                                                                                    | −0.3      |      | 0.3 × VDD | V      |
| DIGITAL OUTPUT: CMOS                             |                                |                                                                                                    |           |      |           |        |
| C <sub>LOAD</sub>                                | Output load capacitance        | f <sub>CLKIN</sub> = 21 MHz                                                                        |           | 15   | 30        | pF     |
| V <sub>OH</sub>                                  | High-level output voltage      | I <sub>OH</sub> = −20 μA                                                                           | VDD − 0.1 |      |           | V      |
|                                                  |                                | I <sub>OH</sub> = −4 mA                                                                            | VDD − 0.4 |      |           |        |
| V <sub>OL</sub>                                  | Low-level output voltage       | I <sub>OL</sub> = 20 μA                                                                            |           |      | 0.1       | V      |
|                                                  |                                | I <sub>OL</sub> = 4 mA                                                                             |           |      | 0.4       |        |
| POWER SUPPLY                                     |                                |                                                                                                    |           |      |           |        |
| I <sub>VDD</sub>                                 | High-side supply current       | 3.0 V ≤ VDD ≤ 3.6 V, I <sub>REFOUT</sub> = 0 mA, MCE = 0, C <sub>LOAD</sub> = 15 pF                |           | 5.2  | 6.8       | mA     |
|                                                  |                                | 3.0 V ≤ VDD ≤ 3.6 V, I <sub>REFOUT</sub> = 0 mA, MCE = 1, C <sub>LOAD</sub> = 15 pF <sup>(8)</sup> |           | 4.6  | 6.1       |        |
|                                                  |                                | 4.5 V ≤ VDD ≤ 5.5 V, I <sub>REFOUT</sub> = 0 mA, MCE = 0, C <sub>LOAD</sub> = 15 pF                |           | 6.4  | 8.3       |        |
|                                                  |                                | 4.5 V ≤ VDD ≤ 5.5 V, I <sub>REFOUT</sub> = 0 mA, MCE = 1, C <sub>LOAD</sub> = 15 pF <sup>(8)</sup> |           | 5.4  | 7.2       |        |

(7) Capacitive load with a value  $\geq 1\text{ nF}$  requires series resistor to be connected to the REFOUT pin. See the [Reference Output](#) section for more details.

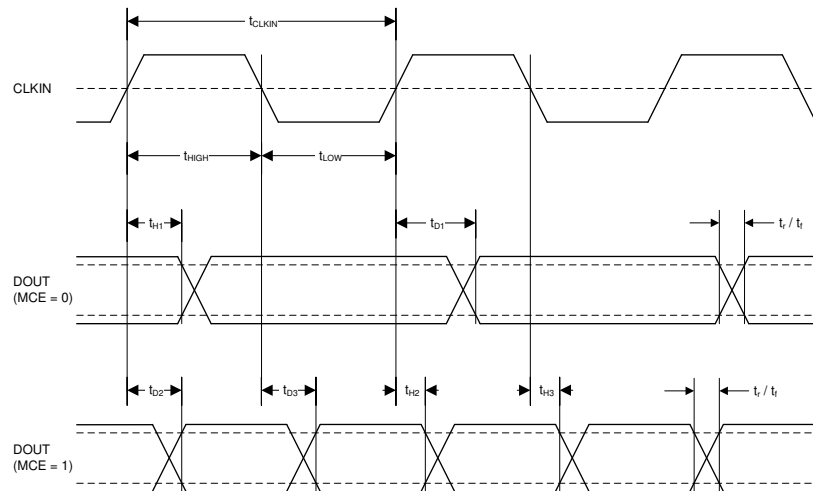
(8) Typical value is specified at  $f_{\text{CLKIN}} = 10\text{ MHz}$ , maximum value is specified at  $f_{\text{CLKIN}} = 11\text{ MHz}$ .

## 6.6 Switching Characteristics

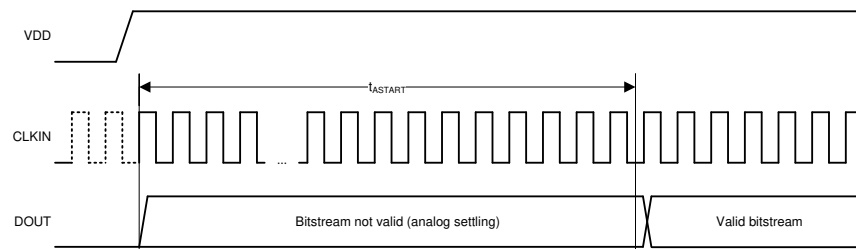
over operating free-air temperature range (unless otherwise noted)

| PARAMETER             |                                            | TEST CONDITIONS                                                                                       | MIN | TYP  | MAX | UNIT |
|-----------------------|--------------------------------------------|-------------------------------------------------------------------------------------------------------|-----|------|-----|------|
| $f_{\text{CLKIN}}$    | CLKIN clock frequency                      | MCE = 0                                                                                               | 9   | 20   | 21  | MHz  |
|                       |                                            | MCE = 1                                                                                               | 9   | 10   | 11  |      |
| Duty <sub>Cycle</sub> | CLKIN clock duty cycle <sup>(1)</sup>      |                                                                                                       | 40% | 50%  | 60% |      |
| $t_{\text{H1}}$       | DOUT hold time after rising edge of CLKIN  | MCE = 0, $C_{\text{LOAD}} = 15 \text{ pF}$                                                            | 6   |      |     | ns   |
| $t_{\text{H2}}$       | DOUT hold time after rising edge of CLKIN  | MCE = 1, $C_{\text{LOAD}} = 15 \text{ pF}$                                                            | 6   |      | 23  | ns   |
| $t_{\text{H3}}$       | DOUT hold time after falling edge of CLKIN | MCE = 1, $C_{\text{LOAD}} = 15 \text{ pF}$                                                            | 10  |      | 26  | ns   |
| $t_{\text{D1}}$       | Rising edge of CLKIN to DOUT valid delay   | MCE = 0, $C_{\text{LOAD}} = 15 \text{ pF}$                                                            |     |      | 25  | ns   |
| $t_{\text{D2}}$       | Rising edge of CLKIN to DOUT valid delay   | MCE = 1, $C_{\text{LOAD}} = 15 \text{ pF}$                                                            | 11  |      | 27  | ns   |
| $t_{\text{D3}}$       | Falling edge of CLKIN to DOUT valid delay  | MCE = 1, $C_{\text{LOAD}} = 15 \text{ pF}$                                                            | 15  |      | 30  | ns   |
| $t_r$                 | DOUT rise time                             | 10% to 90%, $3.0 \text{ V} \leq \text{VDD} \leq 3.6 \text{ V}$ ,<br>$C_{\text{LOAD}} = 15 \text{ pF}$ |     | 2.5  | 5   | ns   |
|                       |                                            | 10% to 90%, $4.5 \text{ V} \leq \text{VDD} \leq 5.5 \text{ V}$ ,<br>$C_{\text{LOAD}} = 15 \text{ pF}$ |     | 1.5  | 3.5 |      |
| $t_f$                 | DOUT fall time                             | 90% to 10%, $3.0 \text{ V} \leq \text{VDD} \leq 3.6 \text{ V}$ ,<br>$C_{\text{LOAD}} = 15 \text{ pF}$ |     | 2.5  | 5.8 | ns   |
|                       |                                            | 90% to 10%, $4.5 \text{ V} \leq \text{VDD} \leq 5.5 \text{ V}$ ,<br>$C_{\text{LOAD}} = 15 \text{ pF}$ |     | 1.8  | 4.4 |      |
| $t_{\text{ASTART}}$   | Analog startup time                        | VDD step to 3.0 V, 0.1% settling,<br>CLKIN applied                                                    |     | 0.25 |     | ms   |

(1) The duty cycle of DOUT equals the clock duty cycle of the applied CLKIN signal.



**Figure 1. Digital Interface Timing**



**Figure 2. Device Startup Timing**

## 6.7 Typical Characteristics

at  $V_{DD} = 3.3\text{ V}$ ,  $A_{INP} = -1\text{ V}$  to  $1\text{ V}$ ,  $A_{INN} = \text{GND}$ ,  $f_{CLKIN} = 20\text{ MHz}$ ,  $MCE = 0$ , and sinc<sup>3</sup> filter with  $OSR = 256$  (unless otherwise noted)

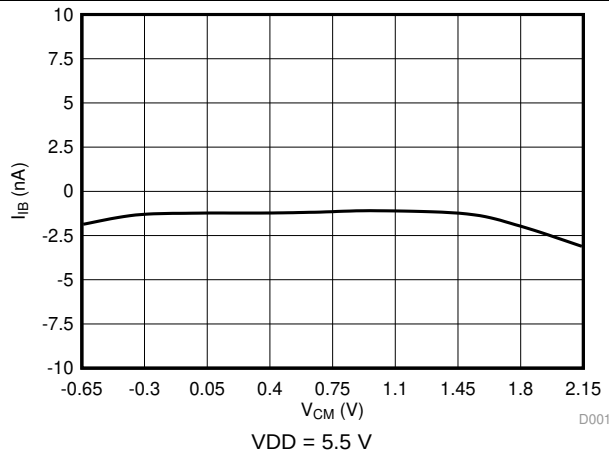


Figure 3. Input Bias Current vs Common-Mode Input Voltage

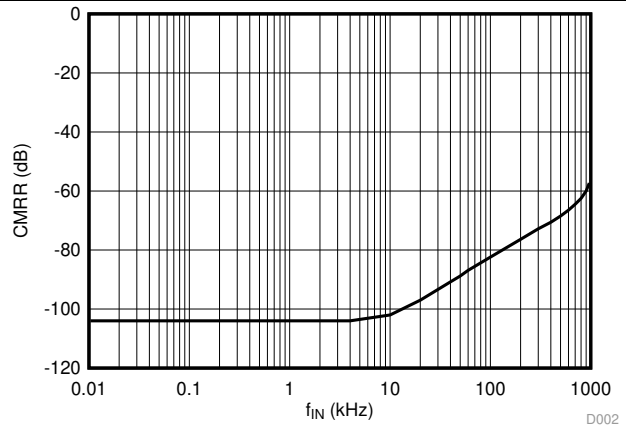


Figure 4. Common-Mode Rejection Ratio vs Input Signal Frequency

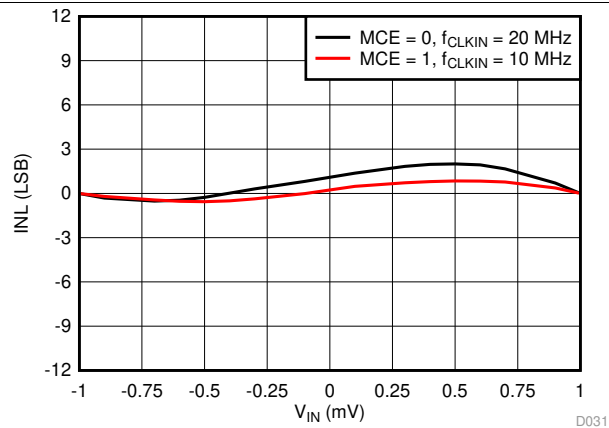


Figure 5. Integral Nonlinearity vs Input Voltage

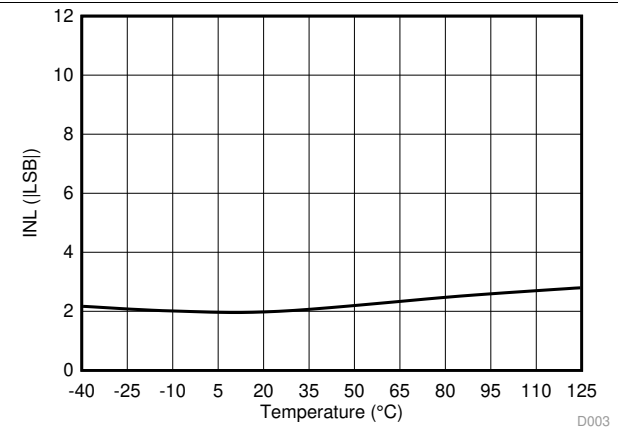


Figure 6. Integral Nonlinearity vs Temperature

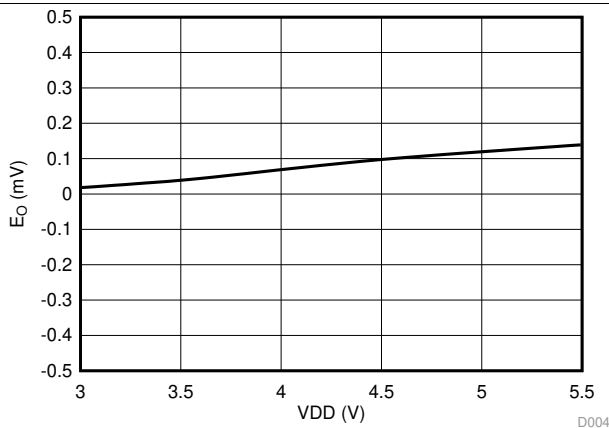


Figure 7. Offset Error vs Supply Voltage

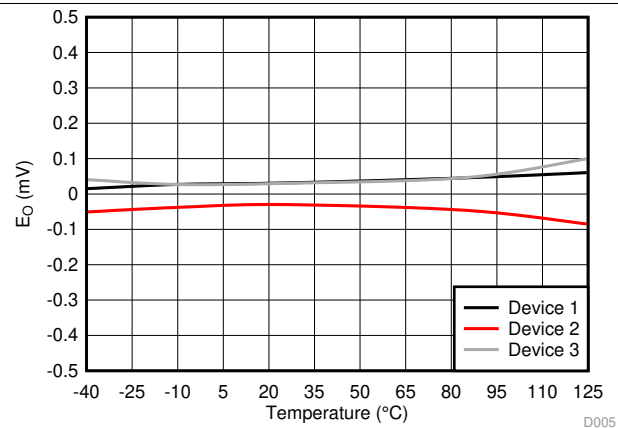


Figure 8. Offset Error vs Temperature



## Typical Characteristics (continued)

at  $V_{DD} = 3.3\text{ V}$ ,  $A_{INP} = -1\text{ V}$  to  $1\text{ V}$ ,  $A_{INN} = \text{GND}$ ,  $f_{CLKIN} = 20\text{ MHz}$ ,  $MCE = 0$ , and sinc<sup>3</sup> filter with  $OSR = 256$  (unless otherwise noted)

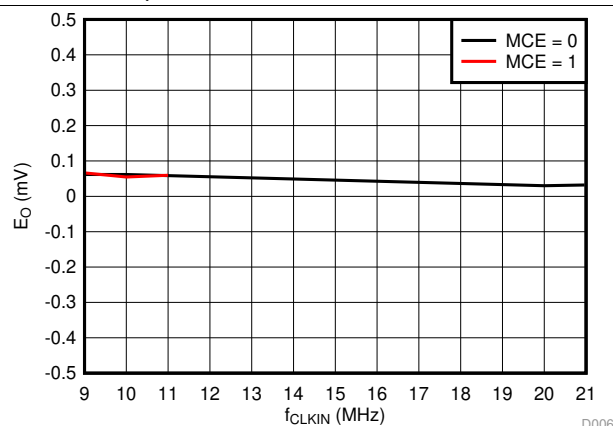


Figure 9. Offset Error vs Clock Frequency

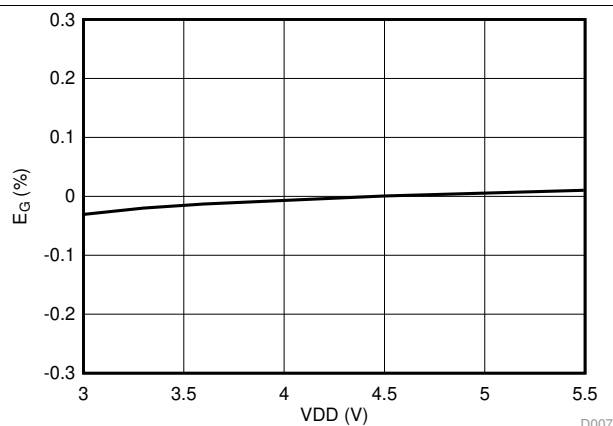


Figure 10. Gain Error vs Supply Voltage

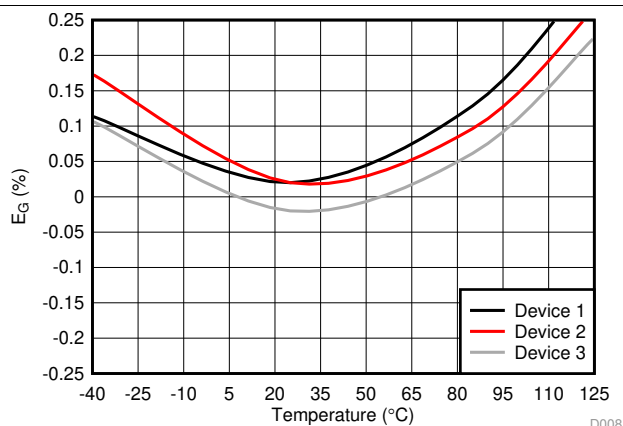


Figure 11. Gain Error vs Temperature

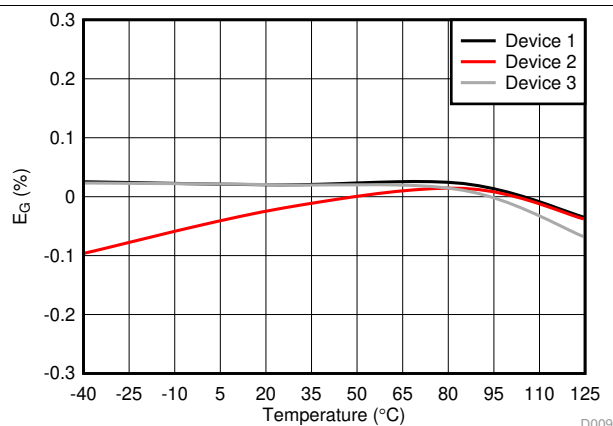


Figure 12. Ratiometric Gain Error vs Temperature

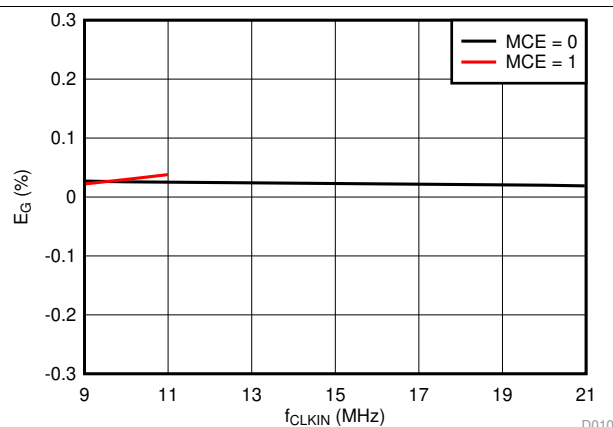


Figure 13. Gain Error vs Clock Frequency

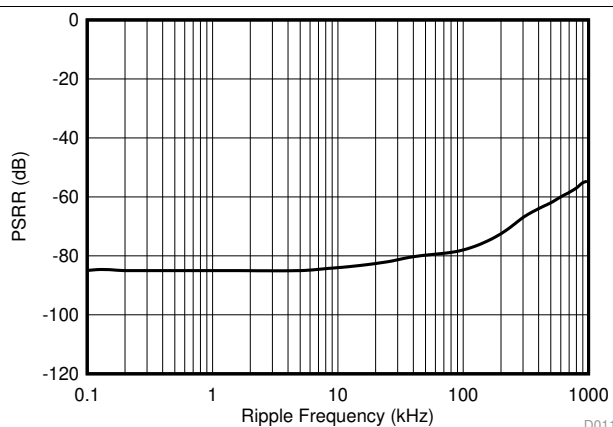


Figure 14. Power-Supply Rejection Ratio vs Ripple Frequency

## Typical Characteristics (continued)

at  $V_{DD} = 3.3\text{ V}$ ,  $A_{INP} = -1\text{ V}$  to  $1\text{ V}$ ,  $A_{INN} = \text{GND}$ ,  $f_{CLKIN} = 20\text{ MHz}$ ,  $MCE = 0$ , and sinc<sup>3</sup> filter with  $OSR = 256$  (unless otherwise noted)

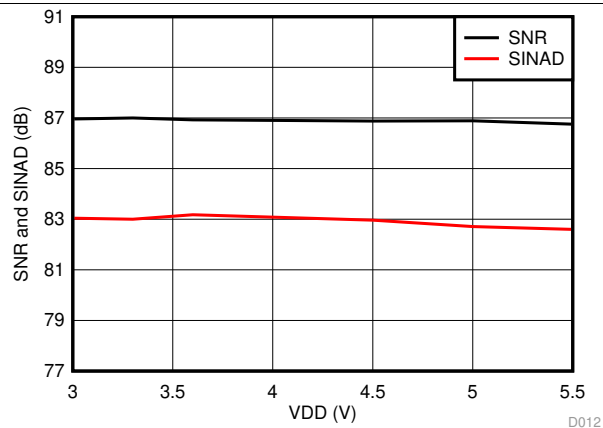


Figure 15. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Supply Voltage

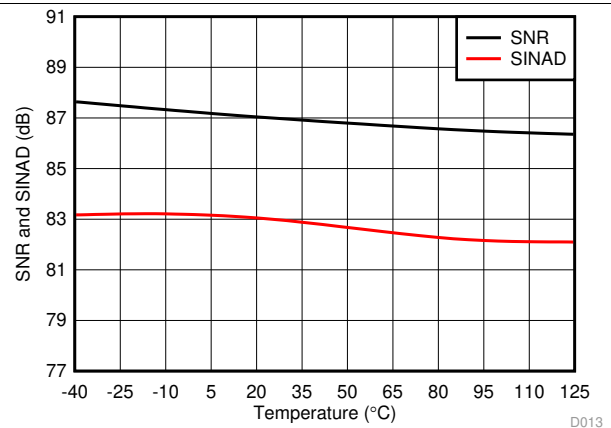


Figure 16. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Temperature

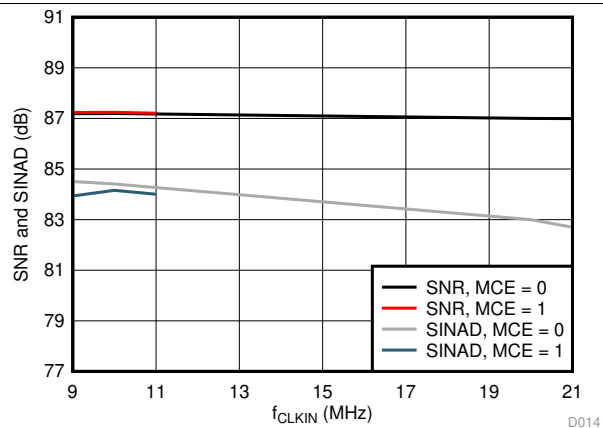


Figure 17. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Clock Frequency

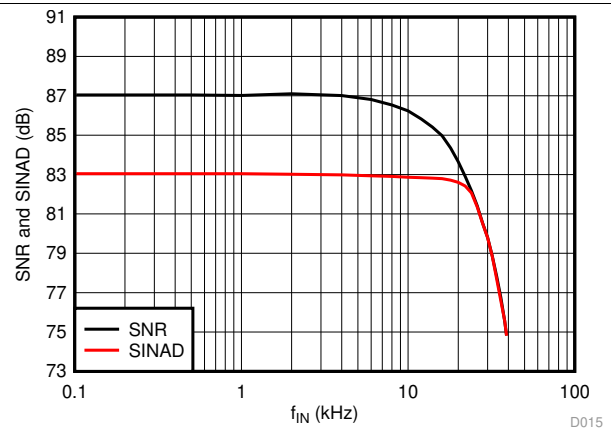


Figure 18. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Input Signal Frequency

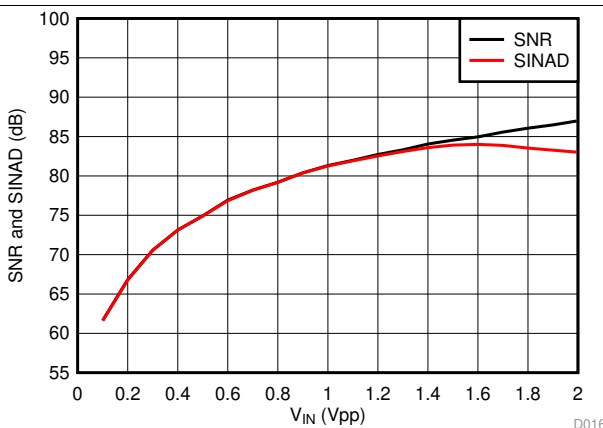


Figure 19. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Input Signal Amplitude

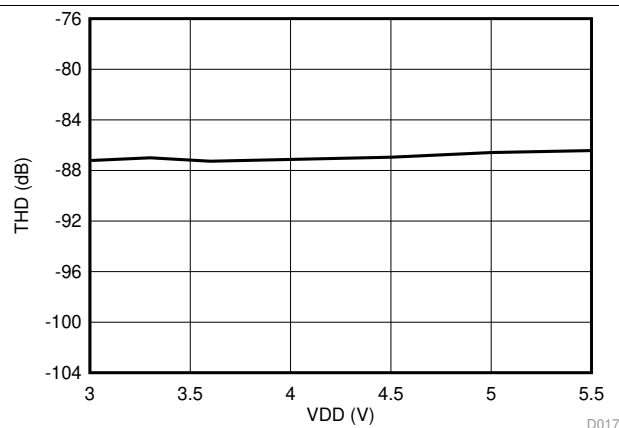


Figure 20. Total Harmonic Distortion vs Supply Voltage

## Typical Characteristics (continued)

at  $V_{DD} = 3.3\text{ V}$ ,  $A_{INP} = -1\text{ V}$  to  $1\text{ V}$ ,  $A_{INN} = \text{GND}$ ,  $f_{CLKIN} = 20\text{ MHz}$ ,  $MCE = 0$ , and sinc<sup>3</sup> filter with  $OSR = 256$  (unless otherwise noted)

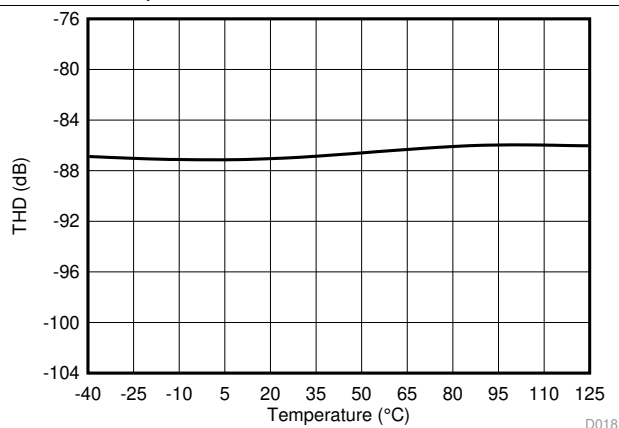


Figure 21. Total Harmonic Distortion vs Temperature

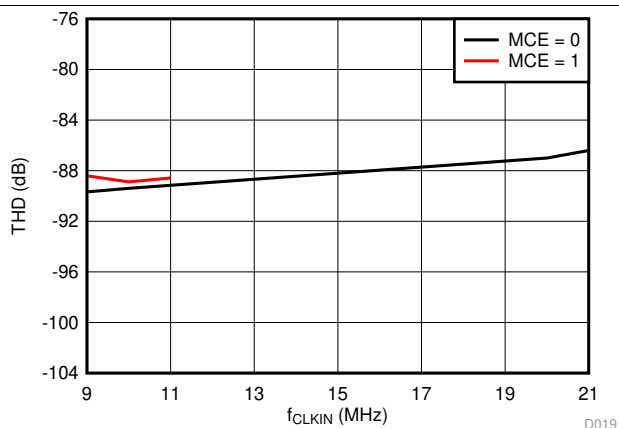


Figure 22. Total Harmonic Distortion vs Clock Frequency

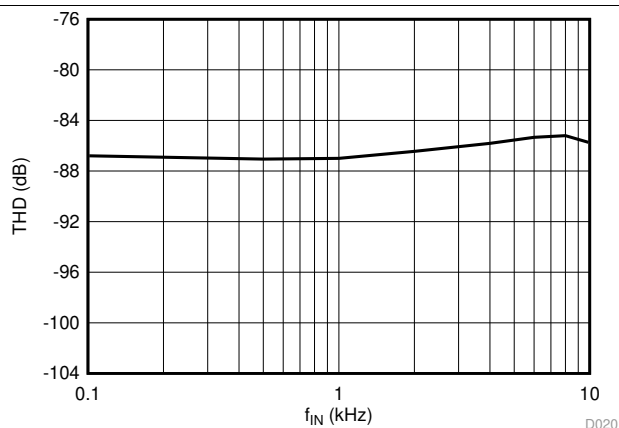


Figure 23. Total Harmonic Distortion vs Input Signal Frequency

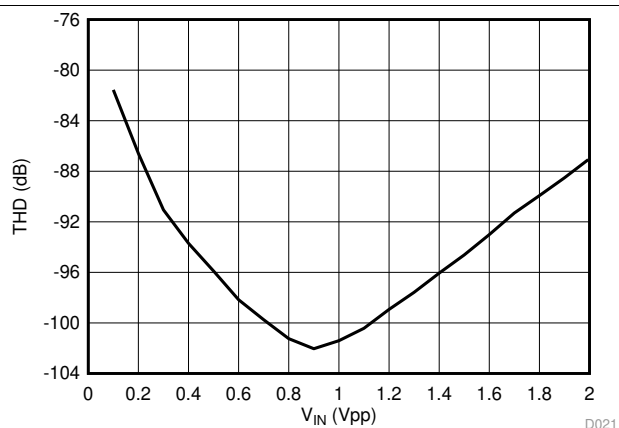


Figure 24. Total Harmonic Distortion vs Input Signal Amplitude

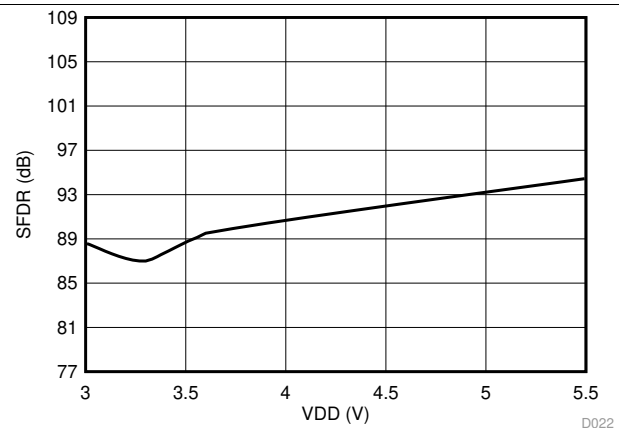


Figure 25. Spurious-Free Dynamic Range vs Supply Voltage

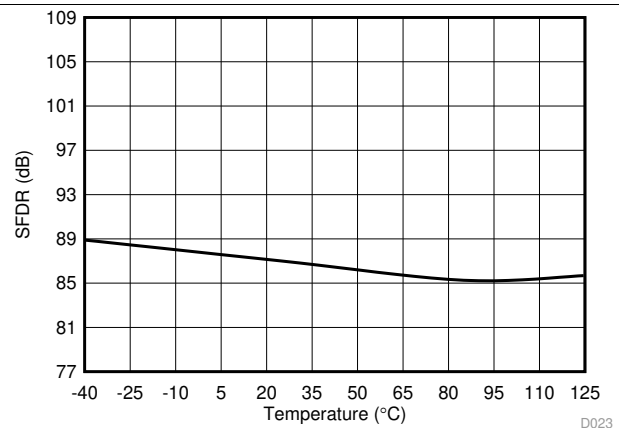


Figure 26. Spurious-Free Dynamic Range vs Temperature

## Typical Characteristics (continued)

at  $V_{DD} = 3.3\text{ V}$ ,  $A_{INP} = -1\text{ V}$  to  $1\text{ V}$ ,  $A_{INN} = \text{GND}$ ,  $f_{CLKIN} = 20\text{ MHz}$ ,  $MCE = 0$ , and  $\text{sinc}^3$  filter with  $\text{OSR} = 256$  (unless otherwise noted)

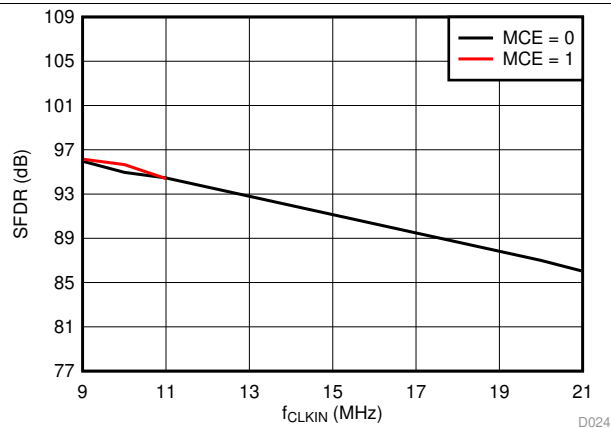


Figure 27. Spurious-Free Dynamic Range vs Clock Frequency

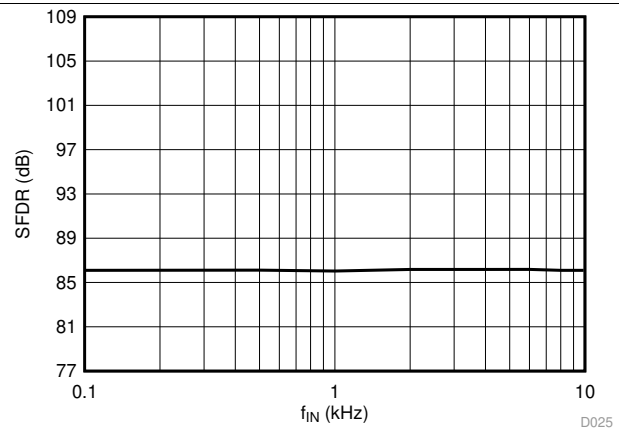


Figure 28. Spurious-Free Dynamic Range vs Input Signal Frequency

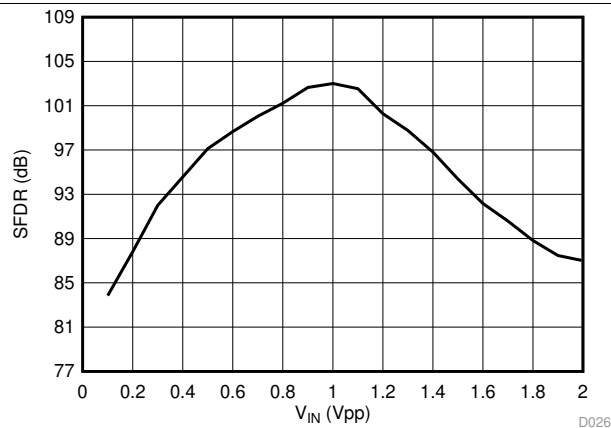


Figure 29. Spurious-Free Dynamic Range vs Input Signal Amplitude

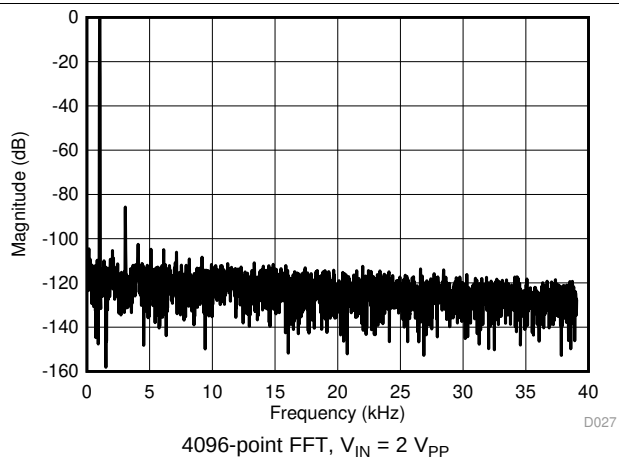


Figure 30. Frequency Spectrum With 1-kHz Input Signal

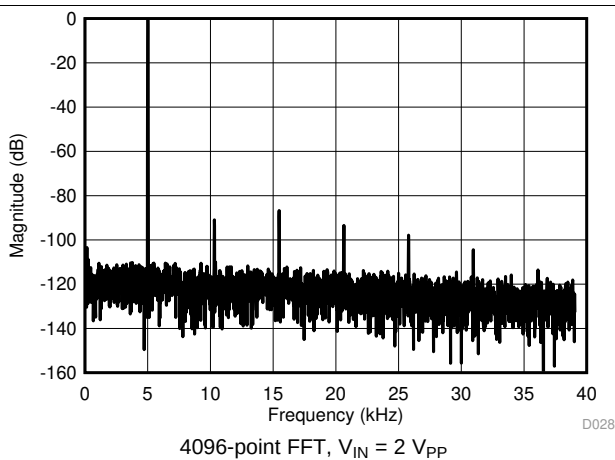


Figure 31. Frequency Spectrum With 5-kHz Input Signal

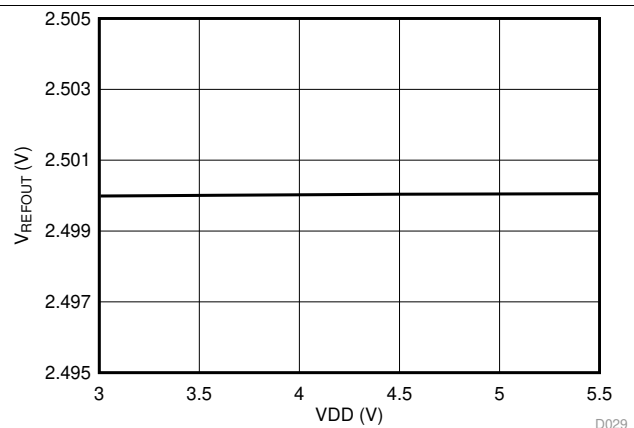


Figure 32. Reference Output Voltage vs Supply Voltage

## Typical Characteristics (continued)

at  $V_{DD} = 3.3\text{ V}$ ,  $A_{INP} = -1\text{ V}$  to  $1\text{ V}$ ,  $A_{INN} = \text{GND}$ ,  $f_{CLKIN} = 20\text{ MHz}$ ,  $MCE = 0$ , and sinc<sup>3</sup> filter with  $OSR = 256$  (unless otherwise noted)

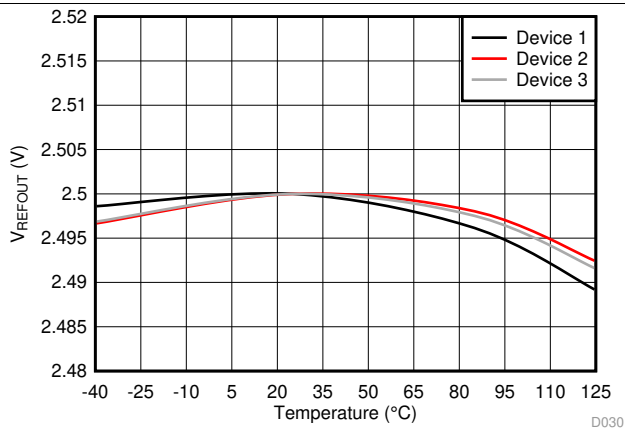


Figure 33. Reference Output Voltage vs Temperature

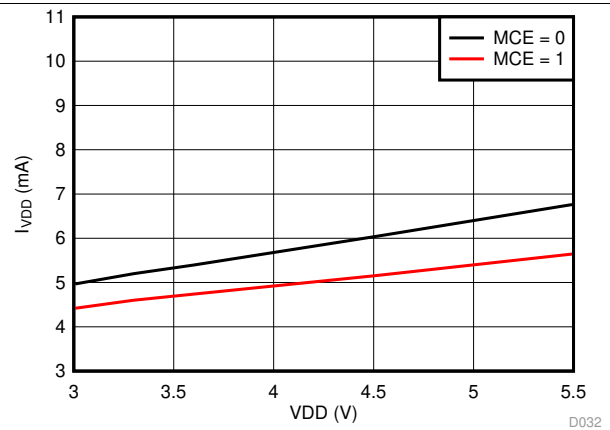


Figure 34. Supply Current vs Supply Voltage

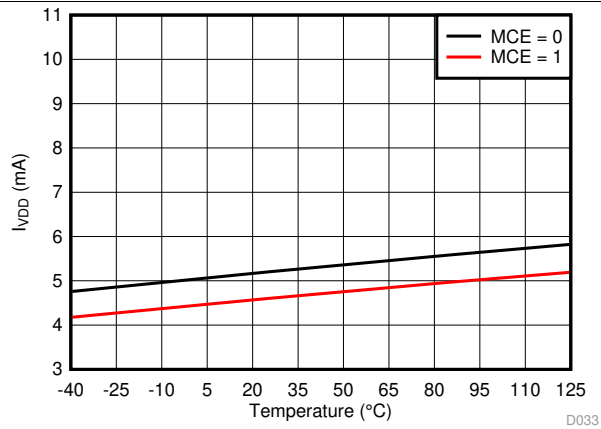


Figure 35. Supply Current vs Temperature

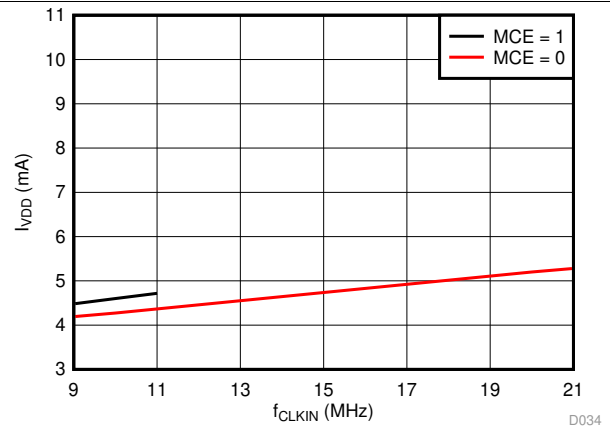


Figure 36. Supply Current vs Clock Frequency

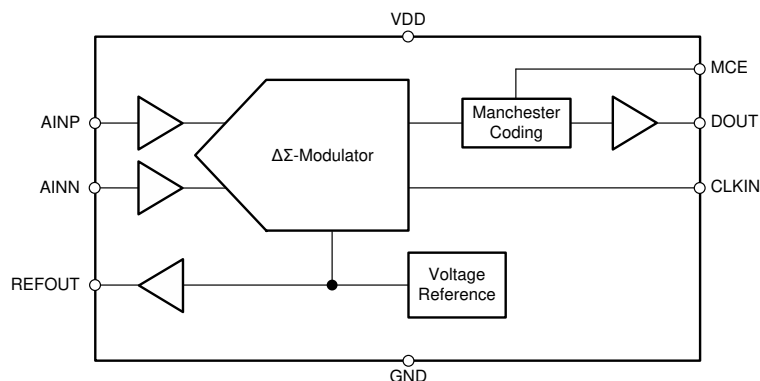
## 7 Detailed Description

### 7.1 Overview

The differential analog input (comprised of input signals AINP and AINN) of the AMC1035 is a chopper-stabilized buffer, followed by the switched-capacitor input of a second-order, delta-sigma ( $\Delta\Sigma$ ) modulator stage that digitizes the input signal into a 1-bit output stream. The data output DOUT of the converter provides a stream of digital ones and zeros that is synchronous to the externally-provided clock source at the CLKIN pin with a frequency in the range of 9 MHz to 21 MHz. The time average of this serial bitstream output is proportional to the analog input voltage.

The [Functional Block Diagram](#) section shows a detailed block diagram of the AMC1035. The 1.6-G $\Omega$  differential input resistance of the analog input stage supports low gain-error signal sensing in high-voltage applications using resistive dividers. The external clock input simplifies the synchronization of multiple measurement channels on the system level. The extended frequency range of up to 21 MHz supports higher performance levels compared to the other solutions available on the market.

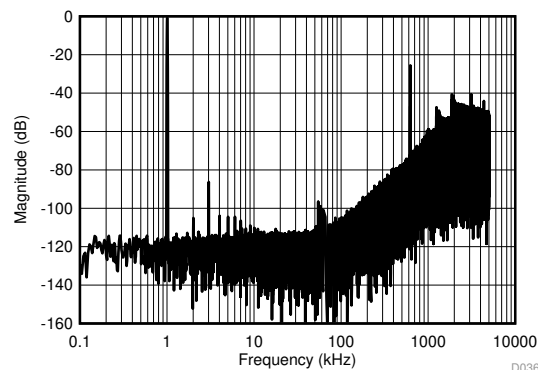
### 7.2 Functional Block Diagram



### 7.3 Feature Description

#### 7.3.1 Analog Input

The AMC1035 incorporates front-end circuitry that contains a buffered sampling stage, followed by a  $\Delta\Sigma$  modulator. To support a bipolar input range, the device uses a charge pump that allows single-supply operation to simplify the overall system design and minimize the circuit cost. For reduced offset and offset drift, the input buffer is chopper-stabilized with the switching frequency set at  $f_{CLKIN} / 32$ . [Figure 37](#) shows the spur created by the switching frequency.



$\text{sinc}^3$  filter,  $\text{OSR} = 2$ ,  $f_{CLKIN} = 20 \text{ MHz}$ ,  $f_{IN} = 1 \text{ kHz}$

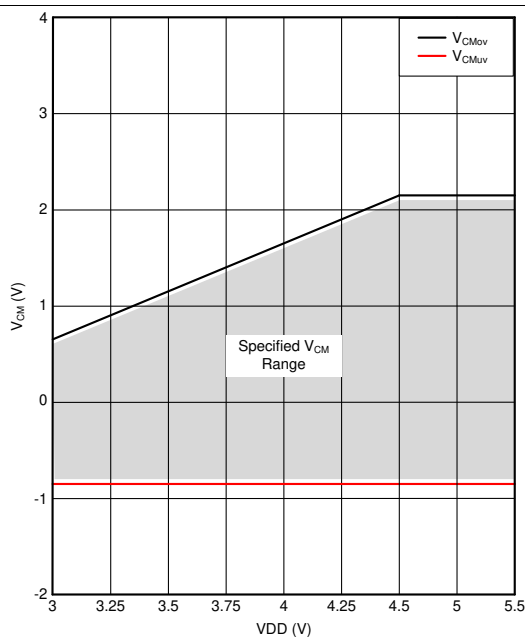
**Figure 37. Quantization Noise Shaping**

## Feature Description (continued)

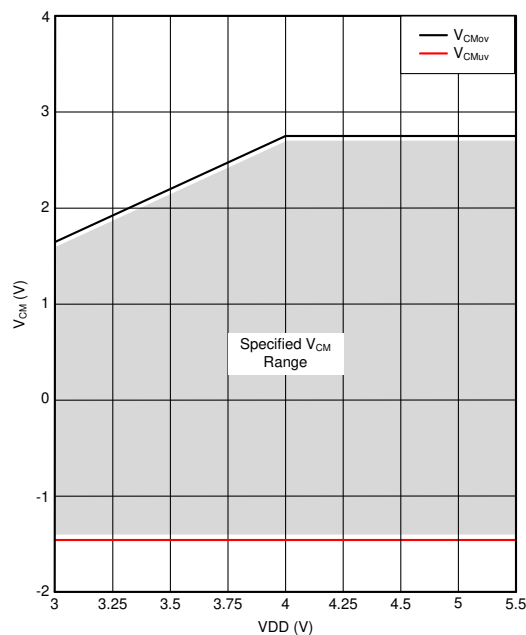
The linearity and noise performance of the device are ensured only when the differential analog input voltage remains within the specified linear full-scale range (FSR), that is  $\pm 1$  V, and within the specified input common-mode range.

Figure 38 shows the specified common-mode input voltage that applies for the full-scale input voltage range as specified in this document along with the corresponding common-mode undervoltage and overvoltage threshold levels.

If smaller input signals are used, the operational common-mode input voltage range widens. Figure 39 shows the common-mode input voltage that applies with no differential input signal; that is, when the voltage applied on AINP is equal to the voltage applied on AINN. The common-mode input voltage range scales with the actual differential input voltage between this range and the range in Figure 38.



**Figure 38. Common-Mode Input Voltage Range With a Full-Scale Differential Input Signal of  $\pm 1.25$  V**

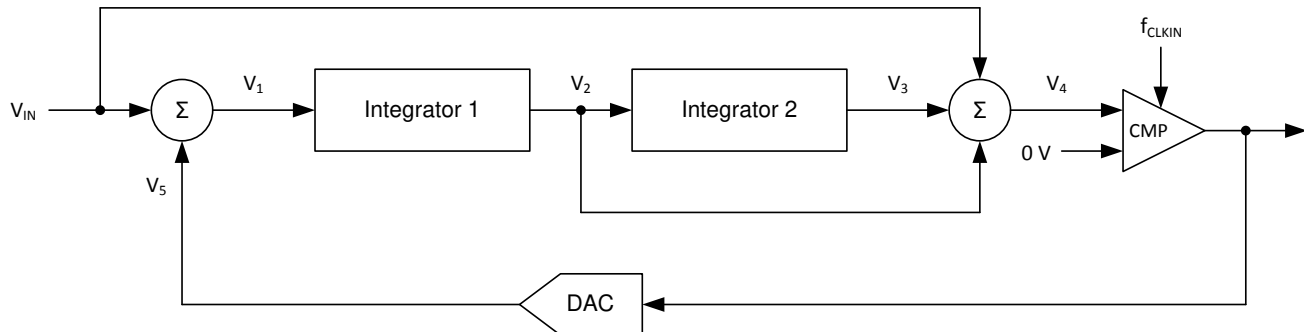


**Figure 39. Common-Mode Input Voltage Range With a Zero Differential Input Signal**

## Feature Description (continued)

### 7.3.2 Modulator

The modulator implemented in the AMC1035 (such as the one conceptualized in [Figure 40](#)) is a second-order, switched-capacitor, feed-forward  $\Delta\Sigma$  modulator. The analog input voltage  $V_{IN}$  and the output  $V_5$  of the 1-bit digital-to-analog converter (DAC) are subtracted, providing an analog voltage  $V_1$  at the input of the first integrator stage. The output of the first integrator feeds the input of the second integrator stage, resulting in output voltage  $V_3$  that is summed with the input signal  $V_{IN}$  and the output of the first integrator  $V_2$ . Depending on the polarity of the resulting voltage  $V_4$ , the output of the comparator is changed. In this case, the 1-bit DAC responds on the next clock pulse by changing the associated analog output voltage  $V_5$ , causing the integrators to progress in the opposite direction and forcing the value of the integrator output to track the average value of the input.



**Figure 40. Block Diagram of a Second-Order Modulator**

As depicted in [Figure 37](#), the modulator shifts the quantization noise to high frequencies. Therefore, use a low-pass digital filter at the output of the device to increase the overall performance. This filter is also used to convert from the 1-bit data stream at a high sampling rate into a higher-bit data word at a lower rate (decimation). TI's microcontroller families [TMS320F28004x](#), [TMS320F2807x](#), and [TMS320F2837x](#) offer a suitable programmable, hardwired filter structure termed a *sigma-delta filter module* (SDFM) optimized for usage with the AMC1035. Also, SD24\_B converters on the [MSP430F677x](#) microcontrollers offer a path to directly access the integrated sinc-filters for a simple system-level solution for multichannel, isolated current sensing. An additional option is to use a suitable application-specific device, such as the [AMC1210](#) (a four-channel digital sinc filter). Alternatively, a field-programmable gate array (FPGA) can be used to implement the filter.

### 7.3.3 Reference Output

The AMC1035 offers a voltage reference output that can source or sink current to significantly reduce the gain error thermal drift in ratiometric applications as specified in the [Electrical Characteristics](#) table. The [IGBT Temperature Sensing](#) section provides an example of a ratiometric use case for the AMC1035.

The reference output can drive capacitive loads less than 1 nF. Use a series resistor to avoid oscillations and degradation of performance for capacitive loads  $\geq 1$  nF. [Table 1](#) lists the recommended series resistor values for given capacitor value examples. Interpolate for capacitive loads with a value between the given examples.

**Table 1. Series Resistor Value for Capacitive Loads  $\geq 1$  nF on REFOUT Pin**

| CAPACITIVE LOAD ON REFOUT PIN | 1 nF        | 3.3 nF      | 10 nF       | 33 nF       | 100 nF      | 330 nF      | 1 $\mu$ F    | 3.3 $\mu$ F  | 10 $\mu$ F   |
|-------------------------------|-------------|-------------|-------------|-------------|-------------|-------------|--------------|--------------|--------------|
| Recommended series resistor   | 33 $\Omega$ | 56 $\Omega$ | 47 $\Omega$ | 33 $\Omega$ | 15 $\Omega$ | 10 $\Omega$ | 5.6 $\Omega$ | 3.3 $\Omega$ | 1.8 $\Omega$ |



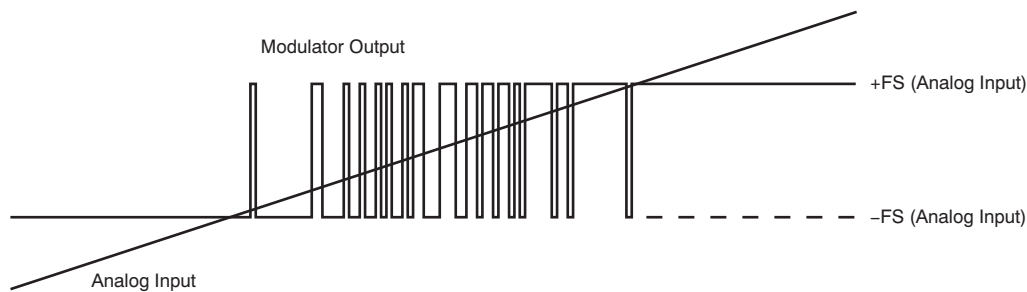
### 7.3.4 Clock Input

The AMC1035 system clock is provided externally at the CLKIN pin. The clock signal must be applied continuously for proper device operation.

To support the bipolar input voltage range with a single supply, the AMC1035 includes a charge pump. This charge pump stops operating if the clock signal is below the specified frequency range or if the signal is paused or missing. Additionally, the input bias current increases beyond the specified range and significantly reduces the input resistance of the device. When the clock signal is paused or missing, the modulator stops the analog signal conversion and the digital output signal remains frozen in the last logic state. When the clock signal is applied again after a pause, the internal analog circuitry biasing must settle for proper device performance. In this case, consider the  $t_{\text{ASTART}}$  specification in the [Switching Characteristics](#) table.

### 7.3.5 Digital Output

A differential input signal of 0 V ideally produces a stream of ones and zeros that are high 50% of the time. A differential input of 1 V produces a stream of ones and zeros that are high 90% of the time. With 16 bits of resolution, that percentage ideally corresponds to code 58982 (an unsigned code). A differential input of –1 V produces a stream of ones and zeros that are high 10% of the time and ideally results in code 6553 with 16-bit resolution. These input voltages are also the specified linear range of the AMC1035 with performance as specified in this document. If the input voltage value exceeds this range, the output of the modulator shows nonlinear behavior when the quantization noise increases. The output of the modulator clips with a stream of only zeros with an input less than or equal to –1.25 V or with a stream of only ones with an input greater than or equal to 1.25 V. In this case, however, the AMC1035 generates a single 1 (if the input is at negative full-scale) or 0 every 128 clock cycles to indicate proper device function (see the [Fail-Safe Output](#) section for more details). [Figure 41](#) shows the input voltage versus the output modulator signal.



**Figure 41. Analog Input versus the AMC1035 Modulator Output**

[Equation 1](#) calculates the density of ones in the output bitstream for any input voltage value (with the exception of a full-scale input signal, as described in the [Output Behavior in Case of a Full-Scale Input](#) section):

$$\frac{V_{\text{IN}} + V_{\text{Clipping}}}{2 \times V_{\text{Clipping}}} \quad (1)$$

The modulator bitstream on the DOUT pin changes with the rising edge of the clock signal applied on the CLKIN pin. Use the rising edge of the clock to latch the modulator bitstream at the input of the digital filter device.

### 7.3.6 Manchester Coding Feature

The AMC1035 offers the IEEE 802.3-compliant Manchester coding feature that generates at least one transition per bit to support clock signal recovery from the bitstream. The Manchester coding combines the clock and data information using exclusive-OR (XOR) logical operation that results in a bitstream free of DC components. [Figure 42](#) shows the resulting bitstream from this coding. The duty cycle of the Manchester encoded bitstream depends on the duty cycle of the input clock CLKIN. To enable Manchester coding on the AMC1035, pull the input pin MCE high. The DOUT signal is inverted if the MCE status changes when CLKIN is high.

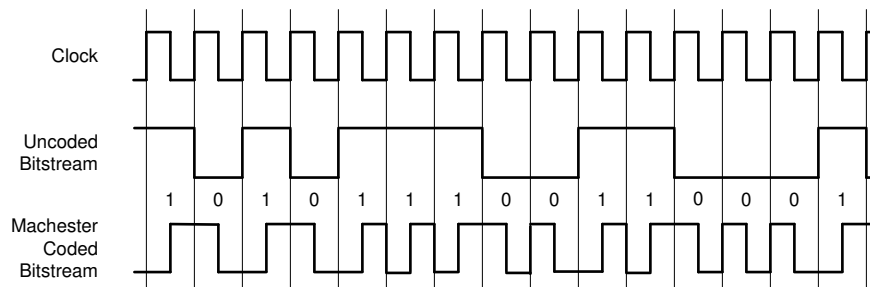


Figure 42. Manchester Coded Output of the AMC1035

## 7.4 Device Functional Modes

The AMC1035 is operational when the power supply VDD and clock signal CLKIN are applied, as specified in [Figure 39](#) and the [Switching Characteristics](#) table.

### 7.4.1 Output Behavior in Case of a Full-Scale Input

If a full-scale input signal is applied to the AMC1035 (that is,  $|V_{IN}| \geq |V_{Clipping}|$ ), the device generates a single one or zero every 128 bits at DOUT, as shown in [Figure 43](#), depending on the actual polarity of the signal being sensed. This feature is also supported with Manchester-coded output and allows full-scale and invalid input signals to be identified as described in the [Fail-Safe Output](#) section and can be used for advanced system-level diagnostics.

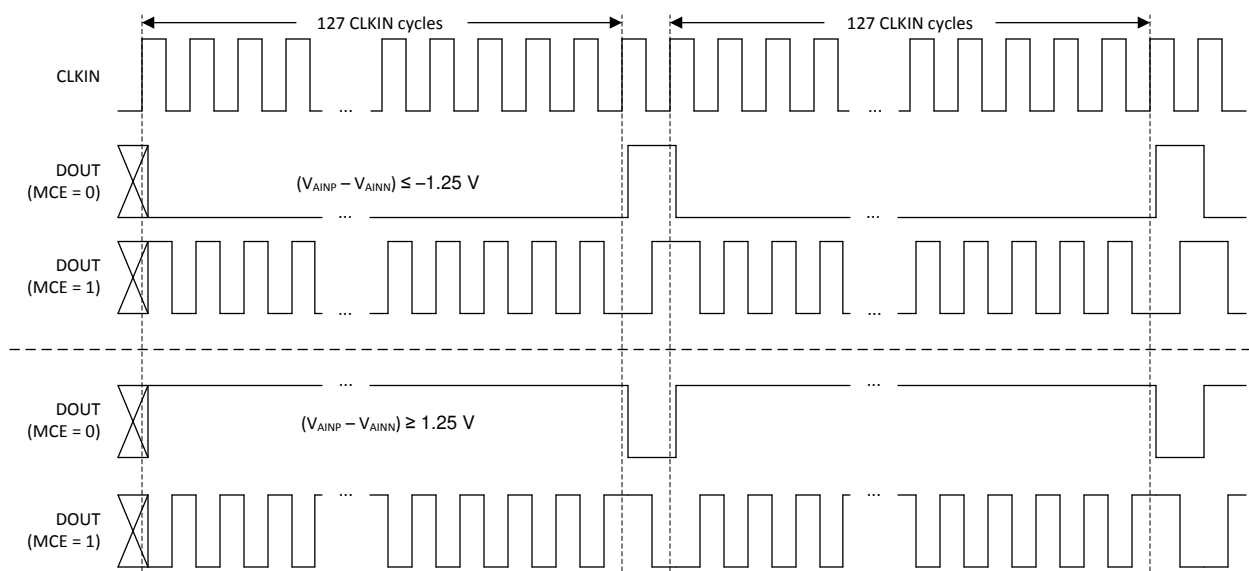
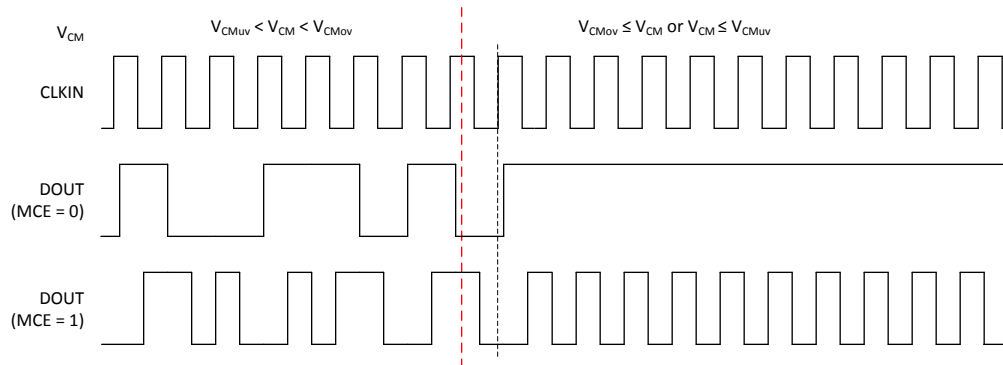


Figure 43. Overrange Output of the AMC1035

## Device Functional Modes (continued)

### 7.4.2 Fail-Safe Output

Figure 44 shows that if the common-mode voltage of the input reaches or exceeds the specified common-mode undervoltage,  $V_{CMUV}$ , or overvoltage detection level,  $V_{CMOV}$  as defined in the [Electrical Characteristics](#) table, the DOUT of the AMC1035 is held at steady-state high.



**Figure 44. Fail-Safe Output of the AMC1035**

## 8 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 8.1 Application Information

#### 8.1.1 Digital Filter Usage

The modulator generates a bitstream that is processed by a digital filter to obtain a digital word similar to a conversion result of a conventional analog-to-digital converter (ADC). Equation 2 shows a sinc<sup>3</sup>-type filter, which is a very simple filter, built with minimal effort and hardware:

$$H(z) = \left( \frac{1 - z^{-OSR}}{1 - z^{-1}} \right)^3 \quad (2)$$

This filter provides the best output performance at the lowest hardware size (count of digital gates) for a second-order modulator. All the characterization in this document is also done with a sinc<sup>3</sup> filter with an oversampling ratio (OSR) of 256 and an output word width of 16 bits.

An example code for implementing a sinc<sup>3</sup> filter in an FPGA is discussed in the [Combining the ADS1202 with an FPGA Digital Filter for Current Measurement in Motor Control Applications](#) application note, available for download at [www.ti.com](http://www.ti.com).

## 8.2 Typical Applications

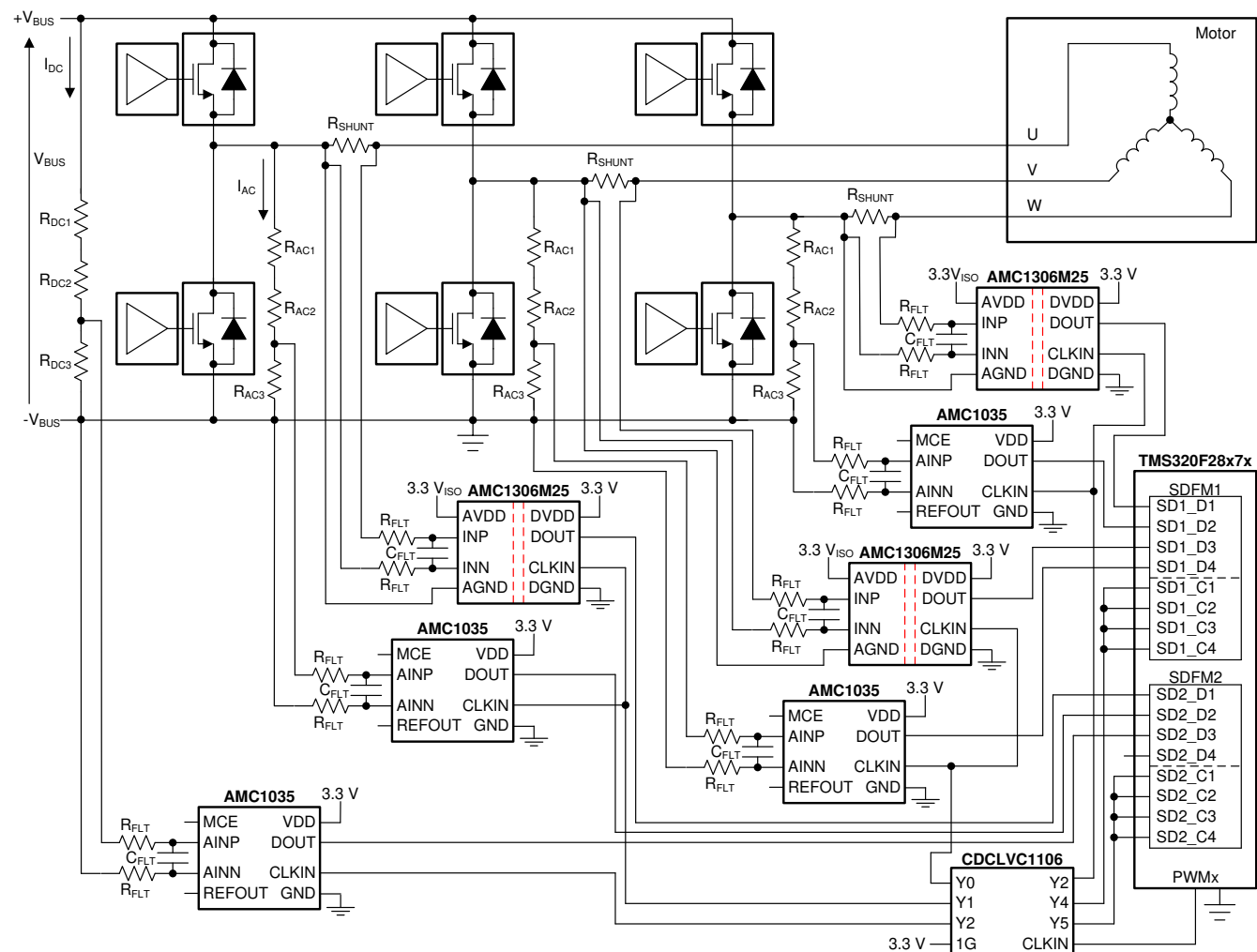
### 8.2.1 Voltage Sensing

$\Delta\Sigma$  modulators are widely used in frequency inverter designs because of their high AC and DC performance. Frequency inverters are critical parts of industrial motor drives, photovoltaic inverters (string and central inverters), uninterruptible power supplies (UPS), and other industrial applications.

Figure 45 shows a simplified schematic of a motor drive application with the AMC1035 used for the DC-link and output phase voltage sensing. In this example, all resistive dividers reference to the negative DC-link voltage that is also used as a ground reference point for the microcontroller. An additional fifth AMC1035 can be used for temperature sensing of the insulated-gate bipolar transistor (IGBT) module; see the [IGBT Temperature Sensing](#) section for more details.

Current feedback is performed with shunt resistors ( $R_{SHUNT}$ ) and TI's [AMC1306M25](#) isolated modulators. Depending on the system design, either all three or only two motor phase currents are sensed.

Depending on the overall digital processing power requirements and with a total of eight  $\Delta\Sigma$  modulator bitstreams to be processed by the MCU, a derivative from either the low-cost single-core [TMS320F2807x](#) or the dual-core [TMS320F2837x](#) families can be used in this application.



**Figure 45. The AMC1035 in a Frequency Inverter Application**

## Typical Applications (continued)

### 8.2.1.1 Design Requirements

Table 2 lists the parameters for this typical application.

**Table 2. Design Requirements**

| PARAMETER                                                                 | VALUE                       |
|---------------------------------------------------------------------------|-----------------------------|
| Supply voltage                                                            | 3.3 V                       |
| Voltage drop across the sensing resistor $R_{DC1}$ for a linear response  | 1 V (maximum)               |
| Voltage drop across the sensing resistors $R_{ACx}$ for a linear response | $\pm 1$ V (maximum)         |
| Current through the sensing resistors $R_{ACx}$                           | $\pm 100$ $\mu$ V (maximum) |

### 8.2.1.2 Detailed Design Procedure

Use Ohm's Law to calculate the minimum total resistance of the resistive dividers to limit the cross current to the desired values:

- For the voltage sensing on the DC bus:  $R_{DC1} + R_{DC2} + R_{DC3} = V_{BUS} / I_{DC}$
- For the voltage sensing on the output phases U, V, and W:  $R_{AC1} + R_{AC2} + R_{AC3} = V_{PHASE(max)} / I_{AC}$

Consider the following two restrictions to choose the proper value of the resistors  $R_{DC3}$  and  $R_{AC3}$ :

- The voltage drop caused by the nominal voltage range of the system must not exceed the recommended input voltage range of the AMC1035:  $V_{XC3} \leq V_{FSR}$
- The voltage drop caused by the maximum allowed system overvoltage must not exceed the input voltage that causes a clipping output:  $V_{XC3} \leq V_{Clipping}$

Use similar approach for calculation of the shunt resistor values  $R_{SHUNT}$  and see the [AMC1306M25 data sheet](#) for further details.

Table 3 lists examples of nominal E96-series (1% accuracy) resistor values for systems using 600 V and 800 V on the DC bus.

**Table 3. Resistor Value Examples for DC Bus Sensing**

| PARAMETER                                            | 600-V DC BUS    | 800-V DC Bus    |
|------------------------------------------------------|-----------------|-----------------|
| Resistive divider resistor $R_{DC1}$                 | 3.01 M $\Omega$ | 4.22 M $\Omega$ |
| Resistive divider resistor $R_{DC2}$                 | 3.01 M $\Omega$ | 4.22 M $\Omega$ |
| Sense resistor $R_{DC3}$                             | 10 k $\Omega$   | 10.5 k $\Omega$ |
| Resulting current through resistive divider $I_{DC}$ | 99.5 $\mu$ A    | 94.7 $\mu$ A    |
| Resulting voltage drop on sense resistor $V_{RDC3}$  | 0.995 V         | 0.994 V         |

Table 4 lists examples of nominal E96-series (1% accuracy) resistor values for systems using 230 V and 690 V on the output phases.

**Table 4. Resistor Value Examples for Output Phase Voltage Sensing**

| PARAMETER                                            | $\pm 400$ -V <sub>AC</sub> PHASE | $\pm 690$ -V <sub>AC</sub> PHASE |
|------------------------------------------------------|----------------------------------|----------------------------------|
| Resistive divider resistor $R_{AC1}$                 | 2.0 M $\Omega$                   | 3.48 M $\Omega$                  |
| Resistive divider resistor $R_{AC2}$                 | 2.0 M $\Omega$                   | 3.48 M $\Omega$                  |
| Sense resistor $R_{AC3}$                             | 10.0 k $\Omega$                  | 10.0 k $\Omega$                  |
| Resulting current through resistive divider $I_{AC}$ | 99.8 $\mu$ A                     | 99.0 $\mu$ A                     |
| Resulting voltage drop on sense resistor $V_{RAC3}$  | $\pm 0.998$ V                    | $\pm 0.990$ V                    |

Use a power supply with a nominal voltage of 3.3 V to directly connect all modulators to the microcontroller.

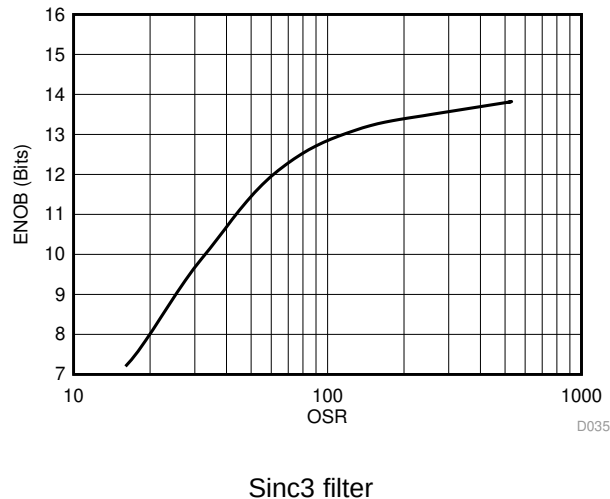
For modulator output bitstream filtering, a device from TI's [TMS320F2807x](#) family of low-cost microcontrollers (MCUs) or [TMS320F2837x](#) family of dual-core MCUs is recommended. These MCU families support up to eight channels of dedicated hardwired filter structures called sigma-delta filter modules (SDFMs) that significantly simplify system level design by offering two filtering paths per channel: one providing high accuracy results for the control loop and one that offers a fast response path for overcurrent detection. Use one of the pulse-width modulation (PWM) sources inside the MCU to generate the clock for the modulators and for easy synchronization of all feedback signals and the switching control of the gate drivers.

[Figure 45](#) uses a clock buffer to distribute the clock reference signal generated on one of the PWM outputs of the MCU (called PWMx in [Figure 45](#)) to all modulators used in the circuit and as a reference for the digital filters in the MCU. In this example, TI's [CDCLVC1106](#) is used for this purpose. Each CDCLVC1106 output can drive a load of 8 pF that is sufficient to drive up to two modulator and up to four SDFM clock inputs.

### 8.2.1.3 Application Curve

The effective number of bits (ENOB) is often used to compare the performance of ADCs and  $\Delta\Sigma$  modulators. [Figure 46](#) shows the ENOB of the AMC1035 with different oversampling ratios on a sinc3 filter. This number is calculated from the SINAD by using [Equation 3](#) in this document.

$$\text{SINAD} = 1.76 \text{ dB} + 6.02 \text{ dB} \times \text{ENOB} \quad (3)$$

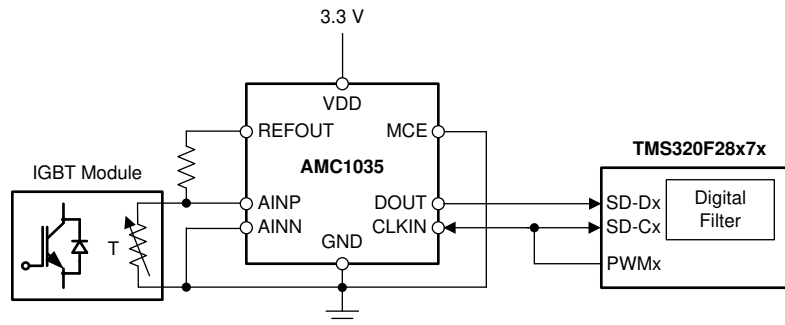


**Figure 46. Measured Effective Number of Bits vs Oversampling Ratio**

## 8.2.2 IGBT Temperature Sensing

The high input impedance of the AMC1035 is optimized for usage in voltage-sensing applications. Additionally, the internal voltage reference supports temperature sensing using a positive temperature coefficient (PTC) or a negative temperature coefficient (NTC) sensor often integrated in the IGBT module.

The same reference is internally used by the modulator, resulting in a ratiometric system solution that minimizes the overall temperature drift of the sensing path. [Figure 47](#) shows a simplified schematic of the AMC1035 used for temperature sensing of the IGBT module.



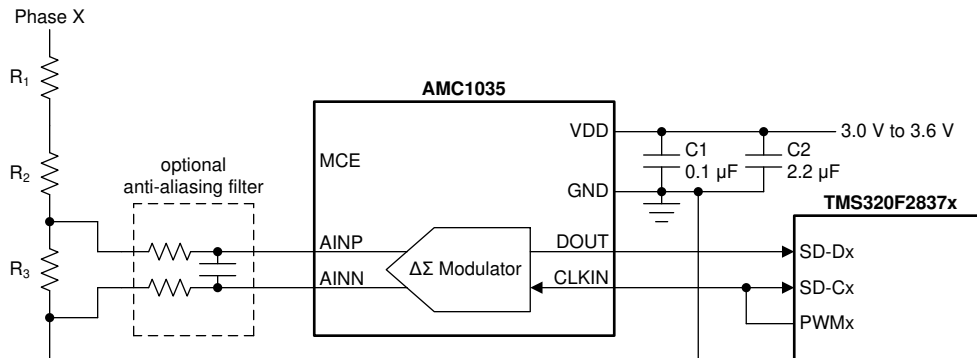
**Figure 47. Using the AMC1035 for Temperature Sensing**

## 8.2.3 What to Do and What Not to Do

Do not leave the analog inputs of the AMC1035 unconnected (floating) when the device is powered up. If either modulator input is left floating, the input bias current may drive this input beyond the specified common-mode input voltage range. If both inputs are beyond that range, the gain of the front-end diminishes. In both cases, the modulator outputs a fail-safe bitstream as described in the [Fail-Safe Output](#) section.

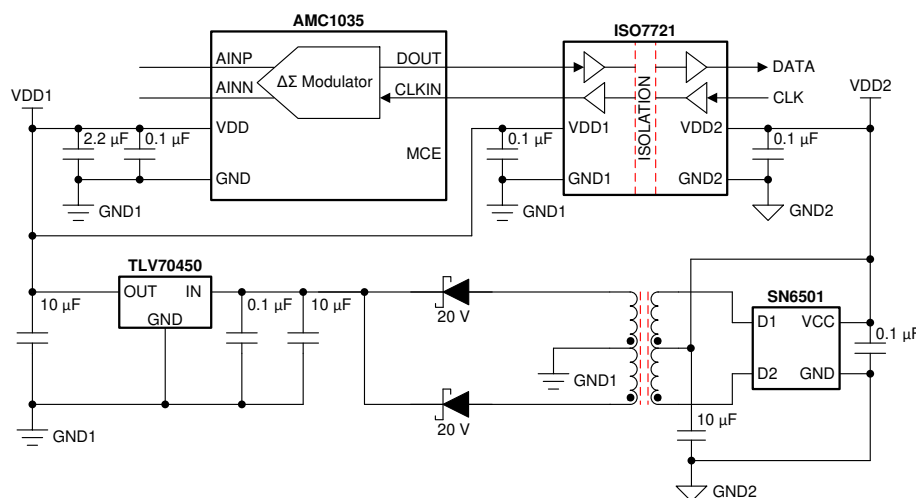
## 9 Power Supply Recommendations

For decoupling of the power supply, a 0.1- $\mu$ F capacitor is recommended to be placed as close to the VDD pin of the AMC1035 as possible, as shown in [Figure 48](#), followed by an additional capacitor in the range of 1  $\mu$ F to 10  $\mu$ F.



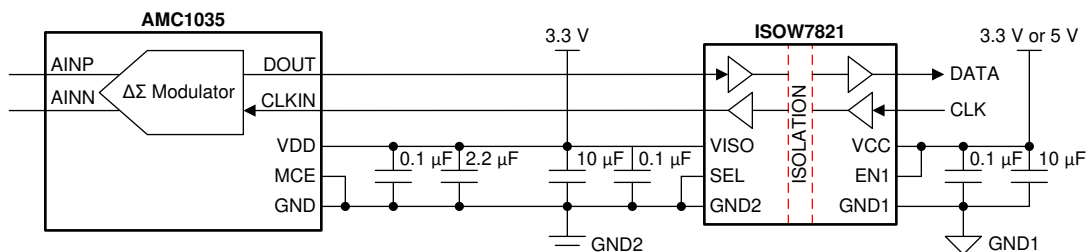
**Figure 48. Decoupling the AMC1035**

Safety considerations or high common-mode voltage levels may require the AMC1035 to be galvanically isolated from other parts of the system. [Figure 49](#) shows an example of a circuit that uses the [ISO7721](#) to isolate the signal path and the SN6501 and a transformer to generate the required isolated power.



**Figure 49. Galvanic Isolation of the AMC1035**

[Figure 50](#) shows an alternative solution that uses the [ISOW7821](#) to isolate the signal path and provide the isolated power supply for the AMC1035.



**Figure 50. Galvanic Isolation of the AMC1035 for PCB Space-Constrained Applications**

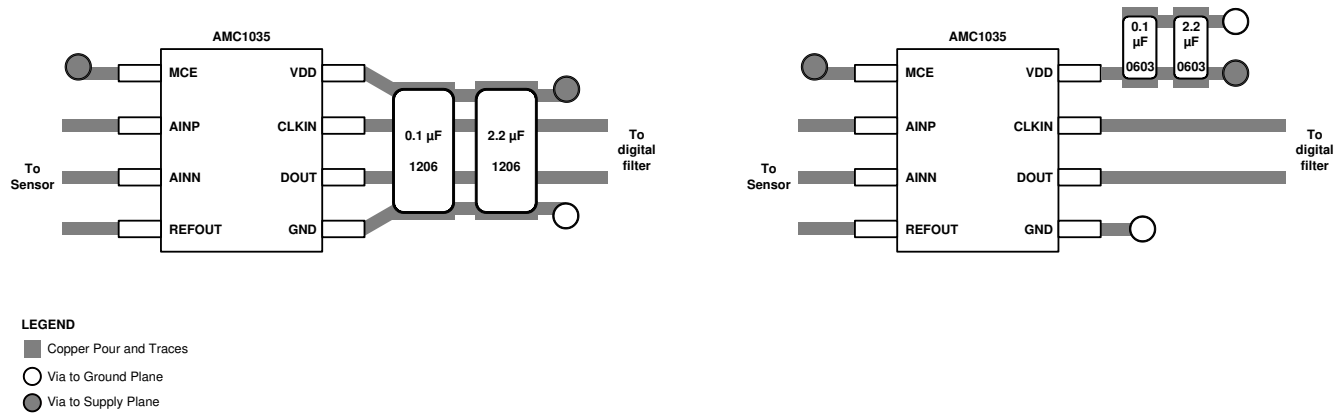


## 10 Layout

### 10.1 Layout Guidelines

Figure 51 shows two layout recommendations for designs based on 1206-SMD or 0603-SMD size decoupling capacitors placed as close as possible to the AMC1035. For best performance, place the AMC1035 as close as possible to the source of the analog signal to be converted and keep the layout of the AINP and AINN traces symmetrical.

### 10.2 Layout Example



**Figure 51. Recommended Layout of the AMC1035**

## 11 Device and Documentation Support

### 11.1 Documentation Support

#### 11.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, [TMS320F28004x Piccolo™ Microcontrollers data sheet](#)
- Texas Instruments, [TMS320F2807x Piccolo™ Microcontrollers data sheet](#)
- Texas Instruments, [TMS320F2837xD Dual-Core Delfino™ Microcontrollers data sheet](#)
- Texas Instruments, [ISO772x High-Speed, Robust EMC Reinforced Dual-Channel Digital Isolators data sheet](#)
- Texas Instruments, [MSP430F677x Polyphase Metering SoCs data sheet](#)
- Texas Instruments, [AMC1210 Quad Digital Filter for 2nd-Order Delta-Sigma Modulator data sheet](#)
- Texas Instruments, [Combining the ADS1202 with an FPGA Digital Filter for Current Measurement in Motor Control Applications application report](#)
- Texas Instruments, [AMC1306x Small, High-Precision, Reinforced Isolated Delta-Sigma Modulators With High CMTI data sheet](#)
- Texas Instruments, [CDCLVC11xx 3.3-V and 2.5-V LVCMOS High-Performance Clock Buffer Family data sheet](#)
- Texas Instruments, [LM117, LM317-N Wide Temperature Three-Pin Adjustable Regulator data sheet](#)
- Texas Instruments, [SN6502 Low-Noise 350mA, 410 kHz Transformer Driver for Isolated Power Supplies data sheet](#)
- Texas Instruments, [ISOW7821 High-Performance, 5000-V<sub>RMS</sub> Reinforced Dual-Channel Digital Isolator With Integrated High-Efficiency, Low-Emissions DC-DC Converter data sheet](#)

#### 11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 11.3 Community Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 11.4 Trademarks

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#### 11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number     | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|---------------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">AMC1035D</a>  | Active        | Production           | SOIC (D)   8   | 75   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | MC1035              |
| AMC1035D.Z                | Active        | Production           | SOIC (D)   8   | 75   TUBE             | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | MC1035              |
| <a href="#">AMC1035DR</a> | Active        | Production           | SOIC (D)   8   | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | MC1035              |
| AMC1035DR.Z               | Active        | Production           | SOIC (D)   8   | 2500   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | MC1035              |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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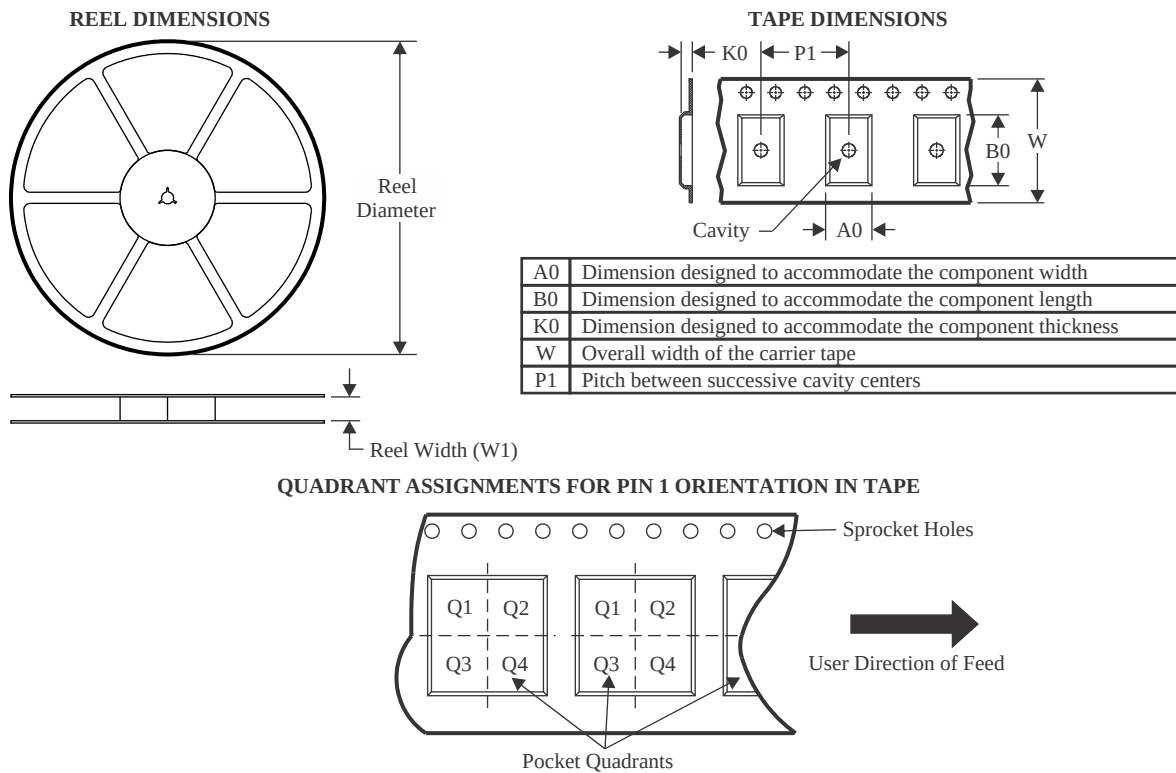
## OTHER QUALIFIED VERSIONS OF AMC1035 :

- Automotive : [AMC1035-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

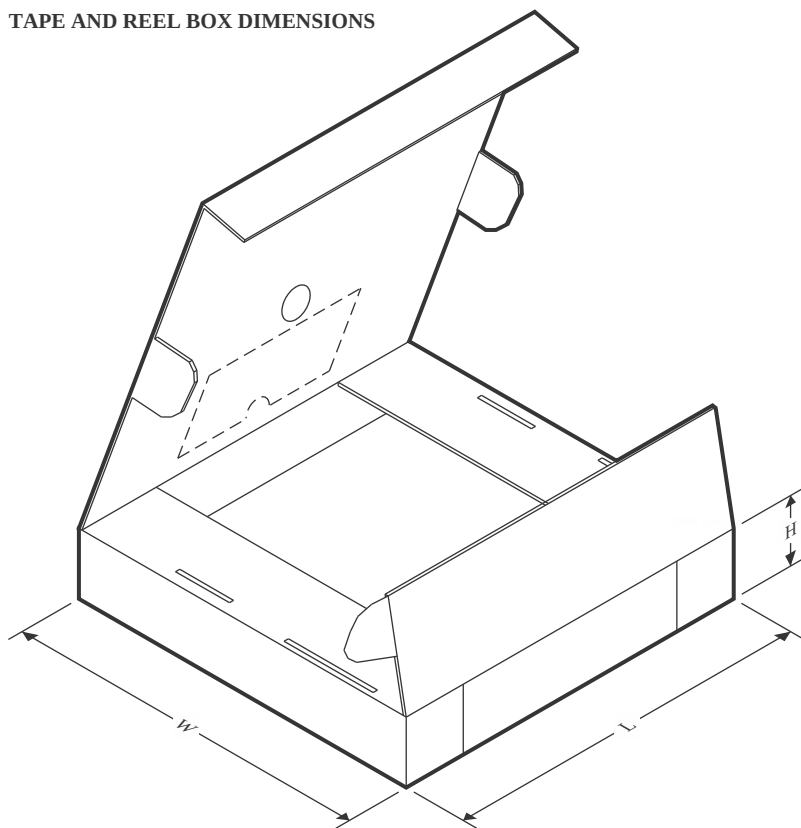
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device    | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| AMC1035DR | SOIC         | D               | 8    | 2500 | 330.0              | 12.4               | 6.4     | 5.2     | 2.1     | 8.0     | 12.0   | Q1            |

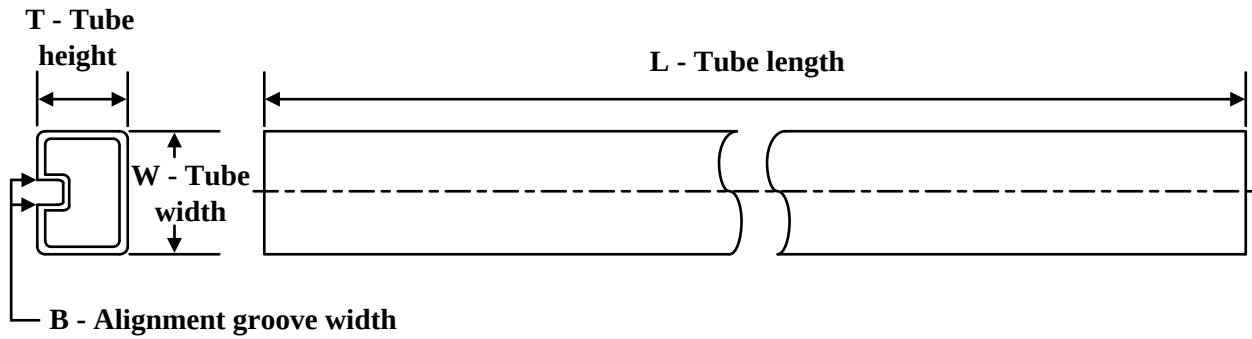
## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device    | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-----------|--------------|-----------------|------|------|-------------|------------|-------------|
| AMC1035DR | SOIC         | D               | 8    | 2500 | 353.0       | 353.0      | 32.0        |

## TUBE



\*All dimensions are nominal

| Device     | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| AMC1035D   | D            | SOIC         | 8    | 75  | 507    | 8      | 3940   | 4.32   |
| AMC1035D.Z | D            | SOIC         | 8    | 75  | 507    | 8      | 3940   | 4.32   |





**SOIC - 1.75 mm max height**

4214825/C 02/2019



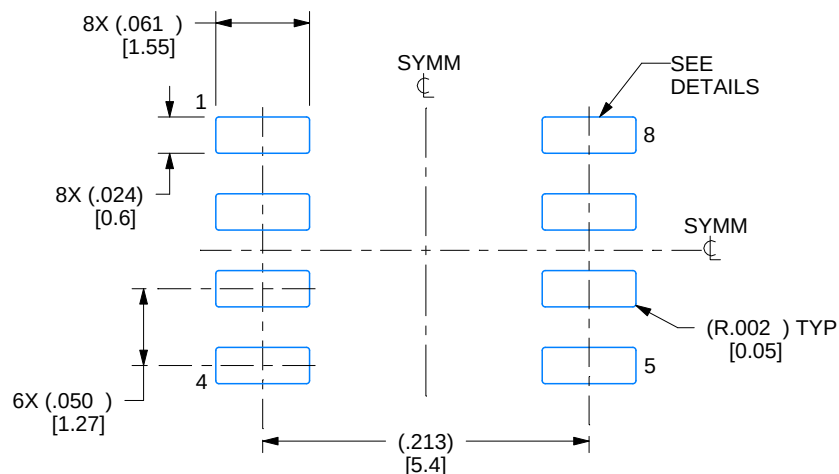
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# EXAMPLE BOARD LAYOUT

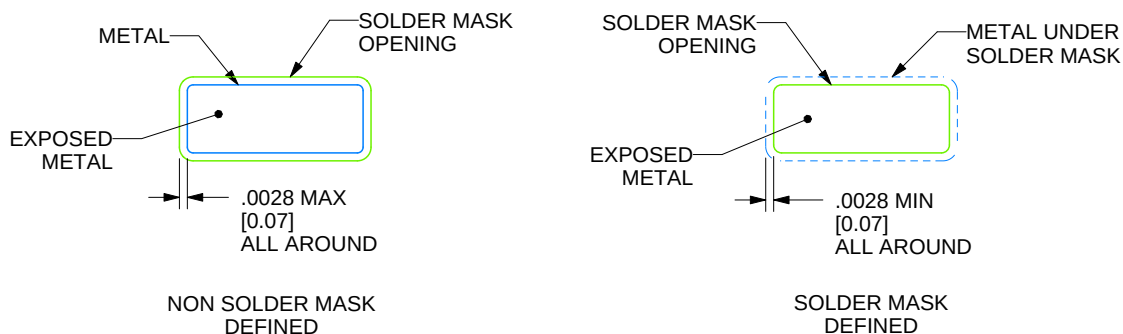
D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

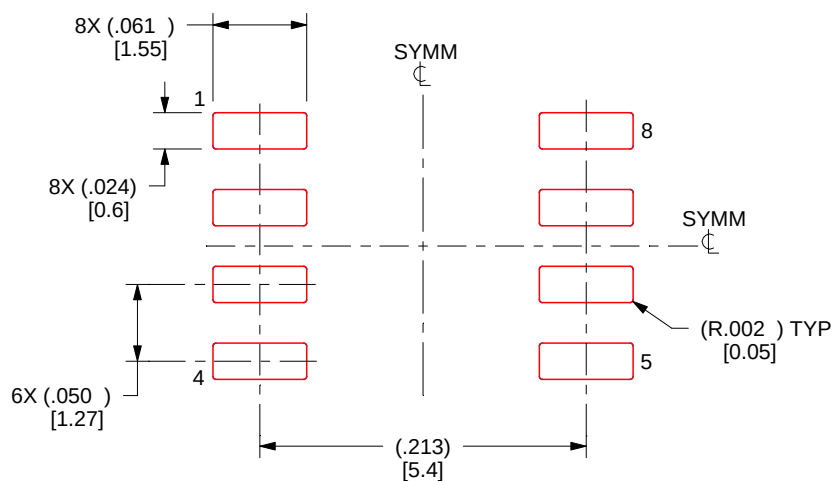
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.125 MM] THICK STENCIL  
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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